RF Exposure Report

(Part 2: Test Under Dynamic Transmission Condition)

FCC ID : IHDT56AC1

Equipment: Mobile Cellular Phone

Brand Name : Motorola Model Name : XT2175-1

Applicant : Motorola Mobility LLC

222 W, Merchandise Mart Plaza, Chicago IL

60654 USA

We, SPORTON INTERNATIONAL INC., would like to declare that the tested sample has been evaluated in accordance with the test procedures and has been in compliance with the applicable technical standards.

The test results in this report apply exclusively to the tested model / sample. Without written approval of SPORTON INTERNATIONAL INC. EMC & Wireless Communications Laboratory, the test report shall not be reproduced except in full.

Approved by: Cona Huang / Deputy Manager

Qua Grange

Sporton International Inc.

No. 52, Huaya 1st Rd., Guishan Dist., Taoyuan City, Taiwan

History of this test report

Report No.	Version	Description	Issued Date
FA172701C	01	Initial issue of report	Oct. 18, 2021



Contents

	5
2 Tx Varying Transmission Test Cases and Test Proposal	6
3 SAR Time Averaging Validation Test Procedures	9
3.1 Test sequence determination for validation	9
3.2 Test configuration selection criteria for validating Smart Transmit feature	
3.2.1 Test configuration selection for time-varying Tx power transmission	
3.2.2 Test configuration selection for change in call	
3.2.3 Test configuration selection for change in technology/band	
3.2.4 Test configuration selection for change in DSI	
3.2.5 Test configuration selection for SAR exposure switching	
3.3 Test procedures for conducted power measurements	
3.3.2 Change in call scenario	
3.3.3 Change in technology and band	14
3.3.4 Change in antenna	16
3.3.5 Change in DSI	
3.3.6 Change in time window	
3.3.7 SAR exposure switching	
3.4 Test procedure for time-varying SAR measurements	18
4 Test Configurations	21
4.1 WWAN (sub-6) transmission	21
5 Conducted Power Test Results for Sub-6 Smart Transmit Feature Validation	
5.1 Measurement setup	25
5.1 Measurement setup	25
5.1 Measurement setup	25 28 29
5.1 Measurement setup	
5.1 Measurement setup	25 28 29 30 32 34 36 38 40 42
5.1 Measurement setup	25 28 29 30 32 34 36 38 40 42 42
5.1 Measurement setup 5.2 P_{limit} and P_{max} measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2 5.3.5 LTE B42 5.3.6 5G NR Band 38 5.3.7 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.6 Change in DSI test results	25 28 29 30 32 34 36 40 42 42 44 45
5.1 Measurement setup 5.2 P_{limit} and P_{max} measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2 5.3.5 LTE B42 5.3.6 5G NR Band 38 5.3.7 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.6 Change in DSI test results 5.7 Change in Time window / antenna switch test results	25 28 29 30 32 34 36 40 42 42 44 45
5.1 Measurement setup 5.2 Plimit and Pmax measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2 5.3.5 LTE B42 5.3.6 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.6 Change in DSI test results 5.7 Change in Time window / antenna switch test results 5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2	25 28 29 30 32 34 36 36 40 42 44 45 45
5.1 Measurement setup 5.2 P_{limit} and P_{max} measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2 5.3.5 LTE B42 5.3.6 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.6 Change in DSI test results 5.7 Change in Time window / antenna switch test results 5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then	25 28 29 30 32 34 36 38 40 42 44 45 46
5.1 Measurement setup 5.2 P_{limit} and P_{max} measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2 5.3.5 LTE B42 5.3.6 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.6 Change in DSI test results 5.7 Change in Time window / antenna switch test results 5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2 5.7.2 Test case 2: transition from LTE B42 to LTE B2 (i.e., 60s to 100s), then	25 28 29 30 32 34 36 36 40 42 44 45 45
5.1 Measurement setup 5.2 P_{limit} and P_{max} measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2 5.3.5 LTE B42 5.3.6 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.6 Change in DSI test results 5.7 Change in Time window / antenna switch test results 5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2 5.7.2 Test case 2: transition from LTE B42 to LTE B2 (i.e., 60s to 100s), then back to LTE B42	25 28 29 30 32 34 36 40 42 44 45 47 47
5.1 Measurement setup 5.2 Plimit and Pmax measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2 5.3.5 LTE B42 5.3.6 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.6 Change in DSI test results 5.7 Change in Time window / antenna switch test results 5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2 5.7.2 Test case 2: transition from LTE B42 to LTE B2 (i.e., 60s to 100s), then back to LTE B42 5.8 Switch in SAR exposure test results (LTE Inter-Band Uplink CA)	25 28 29 30 32 34 36 40 42 44 45 47 47 47
5.1 Measurement setup 5.2 P_{limit} and P_{max} measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2. 5.3.5 LTE B42. 5.3.6 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.5 Change in the DSI test results 5.7 Change in Time window / antenna switch test results 5.7 Change in Time window / antenna switch test results 5.7 Change in Time window / antenna switch test results 5.7 LT Est case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2 5.7.2 Test case 2: transition from LTE B42 to LTE B2 (i.e., 60s to 100s), then back to LTE B42 5.8 Switch in SAR exposure test results (LTE Inter-Band Uplink CA) 5.9 Switch in SAR exposure test results (EN-DC Combination) 5.10 Verification of WWAN Backoff When WiFi/BT is Transmitting	25 28 29 30 32 34 36 40 42 44 45 45 46 47 51
5.1 Measurement setup 5.2 P _{limit} and P _{max} measurement results 5.3 Time-varying Tx power measurement results 5.3.1 GSM1900 5.3.2 WCDMA B2 5.3.3 WCDMA Band 4 5.3.4 LTE B2 5.3.6 5G NR Band 38 5.3.7 5G NR Band 77 5.4 Change in Call Test Results 5.5 Change in technology/band test results 5.6 Change in DSI test results 5.7 Change in Time window / antenna switch test results 5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2 5.7.2 Test case 2: transition from LTE B42 to LTE B2 (i.e., 60s to 100s), then back to LTE B42 5.8 Switch in SAR exposure test results (LTE Inter-Band Uplink CA) 5.9 Switch in SAR exposure test results (EN-DC Combination)	25 28 29 30 30 32 34 36 36 40 42 44 45 46 47 47 47 51 53

SPORTON LAB. FCC RF Exposure Report

FCC RF Exposure Report	Report No. : FA172701C
6.2 SAR measurement results for time-varying Tx power transmission scenario	57
6.2.1 GSM1900 SAR test results	58
6.2.2 WCDMA B2 SAR test results	60
6.2.3 WCDMA B4 SAR test results	62
6.2.4 LTE B2 SAR test results	64
6.2.5 LTE B42 SAR test results	66

7 Conclusions71



1 Introduction

The equipment under test (EUT) is a portable handset (FCC ID: IHDT56AC1), it contains the Qualcomm modem supporting 2G/3G/4G technologies and 5G NR bands. Both of these modems are enabled with Qualcomm Smart Transmit feature to control and manage transmitting power in real time and to ensure at all times the time-averaged RF exposure is in compliance with the FCC requirement.

This purpose of the Part 2 report is to demonstrate the EUT complies with FCC RF exposure requirement under Tx varying transmission scenarios, thereby validity of Qualcomm Smart Transmit feature for FCC equipment authorization

The P_{limit} used in this report is determined in Part 1 report.

Refer to PART 1 SAR REPORT, for product description and terminology used in this report.

Test Lab Information

Test Firm Name	Sporton International Inc.				
Test Firm Information	No. 52, Huaya 1st Rd., Guishan Dist., Taoyuan City, Taiwan TEL: +886-3-327-3456 FAX: +886-3-328-4978				
Test Firm Registration Number for FCC	553509				
Date of Start during the Test	10/13/2021				
Date of End during the Test	10/13/2021				
Test Engineers	Steven Chang, Aaron Chen				
Report Producer	Carlie Tsai				

2 Tx Varying Transmission Test Cases and Test Proposal

To validate time averaging feature and demonstrate the compliance in Tx varying transmission conditions, the following transmission scenarios are covered in Part 2 test:

- 1. During a time-varying Tx power transmission: To prove that the Smart Transmit feature accounts for Tx power variations in time accurately.
- 2. During a call disconnect and re-establish scenario: To prove that the Smart Transmit feature accounts for history of past Tx power transmissions accurately.
- 3. During technology/band handover: To prove that the Smart Transmit feature functions correctly during transitions in technology/band.
- 4. During DSI (Device State Index) change: To prove that the Smart Transmit feature functions correctly during transition from one device state (DSI) to another.
- 5. During antenna (or beam) switch: To prove that the Smart Transmit feature functions correctly during transitions in antenna (such as AsDiv scenario) or beams (different antenna array configurations).
- 6. SAR vs. PD exposure switching during sub-6+mmW transmission: To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance during transitions in SAR dominant exposure, SAR+PD exposure, and PD dominant exposure scenarios.
- SAR exposure switching between two active radios (radio1 and radio2): To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance when exposure varies among SAR_radio1 only, SAR_radio1 + SAR_radio2, and SAR_radio2 only scenarios.

As described in Part 0 report, the RF exposure is proportional to the Tx power for a SAR- and PD-characterized wireless device. Thus, feature validation in Part 2 can be effectively performed through conducted (for f < 6GHz) and radiated (for $f \ge 6GHz$) power measurement. Therefore, the compliance demonstration under dynamic transmission conditions and feature validation are done in conducted/radiated power measurement setup for transmission scenario 1 through 8.

To add confidence in the feature validation, the time-averaged SAR and PD measurements are also performed but only performed for transmission scenario 1 to avoid the complexity in SAR and PD measurement (such as, for scenario 3 requiring change in SAR probe calibration file to accommodate different bands and/or tissue simulating liquid).

The strategy for testing in Tx varying transmission condition is outlined as follows:

- Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC's SAR and PD limits, through time-averaged power measurements
 - \square Measure conducted Tx power (for f < 6 GHz) versus time, and radiated Tx power (EIRP for f > 10 GHz) versus time.
 - Convert it into RF exposure and divide by respective FCC limits to get normalized exposure versus time.



- Perform running time-averaging over FCC defined time windows.
- Demonstrate that the total normalized time-averaged RF exposure is less than 1 for all transmission scenarios at all times.

Mathematical expression:

- For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit}$$
(1a)

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^{t} \frac{1g_{o}r_{1} \log SAR(t)dt}{FCC SAR \ limit} \le 1$$
(1b)

- For sub-6+mmW transmission:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit}$$
(2a)

$$4cm^{2}PD(t) = \frac{radiated_Tx_power(t)}{radiated_Tx_power_input.power.limit} * 4cm^{2}PD_input.power.limit$$

(2b)

radio.

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^{t} \frac{1g_or_10gSAR(t)dt}{FCC\ SAR\ limit} + \frac{\frac{1}{T_{PD}} \int_{t-T_{PD}}^{t} \frac{4cm^2PD(t)dt}{FCC\ 4cm^2\ PD\ limit} \le 1$$
 (2c)

where, $conducted_Tx_power(t)$, $conducted_Tx_power_P_{limit}$, and 1g_or_10gSAR_P_{limit} correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured 1gSAR or 10gSAR values at P_{limit} corresponding to sub-6 transmission. Similarly, $radiated_Tx_power(t)$, radiated_Tx_power_input.power.limit, and 4cm²PD_input.power.limit correspond to the measured instantaneous radiated Tx power, radiated Tx power at input.power.limit (i.e., radiated power limit), and 4cm²PD value at input.power.limit corresponding to mmW transmission. Both Plimit and input.power.limit are the parameters pre-defined in Part 0 and loaded via Embedded File System (EFS) onto the EUT. T_{SAR} is the FCC defined time window for sub-6 radio; TPD is the FCC defined time window for mmW

Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC's SAR and PD limits, through time-averaged SAR and PD measurements. Note as mentioned earlier, this measurement is performed for transmission scenario 1 only.



- Report No. : FA172701C
- For sub-6 transmission only, measure instantaneous SAR versus time; for LTE+5G NR transmission, request low power (or all-down bits) on LTE so that measured SAR predominantly corresponds to 5G NR.
- □ For LTE + mmW transmission, measure instantaneous E-field versus time for mmW radio and instantaneous conducted power versus time for LTE radio.
- Convert it into RF exposure and divide by respective FCC limits to obtain normalized exposure versus time.
- Perform time averaging over FCC defined time window.
- Demonstrate that the total normalized time-averaged RF exposure is less than 1 for transmission scenario 1 at all times.

Mathematical expression:

For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_P_{limit}} * 1g_or_10gSAR(t)_P_{limit}$$
(3a)

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^{t} \frac{1g_{o}r_{1} \log SAR(t)dt}{FCC SAR \ limit} \le 1$$
(3b)

For LTE+mmW transmission:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit}$$
 (4a)

$$4cm^2PD(t) = \frac{[pointE(t)]^2}{[pointE_input.power.limit]^2} * 4cm^2PD_input.power.limit$$
 (4b)

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^{t} 1g_or_10gSAR(t)dt}{FCC SAR limit} + \frac{\frac{1}{T_{PD}} \int_{t-T_{PD}}^{t} 4cm^2 PD(t)dt}{FCC 4cm^2 PD limit} \le 1 \tag{4c}$$

where, pointSAR(t), $pointSAR_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous point SAR, measured point SAR at P_{limit} , and measured 1gSAR or 10gSAR values at P_{limit} corresponding to sub-6 transmission. Similarly, pointE(t), $pointE_input.power.limit$, and $4cm^2PD_input.power.limit$ correspond to the measured instantaneous E-field, E-field at input.power.limit, and $4cm^2PD_value$ at input.power.limit corresponding to mmW transmission.

NOTE: cDASY6 measurement system by Schmid & Partner Engineering AG (SPEAG) of Zurich, Switzerland measures relative E-field, and provides ratio of $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$ versus time.

3 SAR Time Averaging Validation Test Procedures

This chapter provides the test plan and test procedure for validating Qualcomm Smart Transmit feature for sub-6 transmission. The 100 seconds time window for operating f < 3GHz is used as an example to detail the test procedures in this chapter.

3.1 Test sequence determination for validation

Following the FCC recommendation, two test sequences having time-variation in Tx power are predefined for sub-6 (f < 6 GHz) validation:

- Test sequence 1: request EUT's Tx power to be at maximum power, measured P_{max}^{\dagger} , for 80s, then requesting for half of the maximum power, i.e., measured $P_{max}/2$, for the rest of the time.
- Test sequence 2: request EUT's Tx power to vary with time. This sequence is generated relative to measured P_{limit} , measured P_{limit} and calculated $P_{reserve}$ (= measured P_{limit} in dBm $Reserve_power_margin$ in dB) of EUT based on measured P_{limit} .

The details for generating these two test sequences is described and listed in Appendix A.

NOTE: For test sequence generation, "measured P_{limit} " and "measured P_{max} " are used instead of the " P_{limit} " specified in EFS entry and " P_{max} " specified for the device, because Smart Transmit feature operates against the actual power level of the " P_{limit} " that was calibrated for the EUT. The "measured P_{limit} " accurately reflects what the feature is referencing to, therefore, it should be used during feature validation testing. The RF tune up and device-to-device variation are already considered in Part 0 report prior to determining P_{limit} .

3.2 Test configuration selection criteria for validating Smart Transmit feature

For validating Smart Transmit feature, this section provides a general guidance to select test cases. In practice, an adjustment can be made in test case selection. The justification/clarification may be provided.

3.2.1 Test configuration selection for time-varying Tx power transmission

The Smart Transmit time averaging feature operation is independent of bands, modes, and channels for a given technology. Hence, validation of Smart Transmit in one band/mode/channel per technology is sufficient.

The criteria for the selection are based on the P_{limit} values determined in Part 0 report. Select the band in each supported technology that corresponds to the P_{limit} value that is less than P_{max} for validating Smart Transmit.

Note this test is designed for single radio transmission scenario. If UE supports sub6 NR in both non-standalone (NSA) and standalone (SA) modes, then validation in time-varying Tx power transmission scenario described in this section needs to be performed in SA mode. Otherwise, it needs to be performed in NSA mode with LTE anchor set to low power. The choice between SA and NSA mode needs to also take into account the seletion criteria described below. In general, one mode out of the two modes (NSA or SA) is sufficient for this test.

3.2.2 Test configuration selection for change in call

The criteria to select a test configuration for call-drop measurement is:

- Select technology/band with least P_{limit} among all supported technologies/bands, and select the radio configuration (e.g., # of RBs, channel#) in this technology/band that corresponds to the highest *measured* 1gSAR at P_{limit} listed in Part 1 report.
- In case of multiple bands having same least P_{limit} , then select the band having the highest *measured* 1gSAR at P_{limit} in Part 1 report.

This test is performed with the EUT's Tx power requested to be at maximum power, the above band selection will result in Tx power enforcement (i.e., EUT forced to have Tx power at $P_{reserve}$) for longest duration in one FCC defined time window. The call change (call drop/reestablish) is performed during the Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$). One test is sufficient as the feature operation is independent of technology and band.

3.2.3 Test configuration selection for change in technology/band

The selection criteria for this measurement is, for a given antenna, to have EUT switch from a technology/band with lowest P_{limit} within the technology group (in case of multiple bands having the same P_{limit} , then select the band with highest measured 1gSAR at P_{limit}) to a technology/band with highest P_{limit} within the technology group, in case of multiple bands having the same P_{limit} , then select the band with lowest measured 1gSAR at P_{limit} in Part 1 report, or vice versa.

This test is performed with the EUT's Tx power requested to be at maximum power, the technology/band switch is performed during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

3.2.4 Test configuration selection for change in DSI

The criteria to select a test configuration for DSI change test is

■ Select a technology/band having the $P_{limit} < P_{max}$ within any technology and DSI group, and for the same technology/band having a different P_{limit} in any other DSI group. Note that the selected DSI transition need to be supported by the device.

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band, and DSI change is conducted during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

3.2.5 Test configuration selection for SAR exposure switching

If supported, the test configuration for SAR exposure switching should cover

- 1. SAR exposure switch when two active radios are in the same time window
- SAR exposure switch when two active radios are in different time windows.
 One test with two active radios in any two different time windows is sufficient as Smart Transmit operation is the same for RF exposure switch in any combination of two different time windows. For device supporting LTE + mmW NR, this test is covered in Section 8.2.3 and 8.2.4.

The Smart Transmit time averaging operation is independent of the source of SAR exposure (for example, LTE vs. 5G NR) and ensures total time-averaged RF exposure compliance. Hence, validation of Smart Transmit in any one simultaneous SAR transmission scenario (i.e., one combination for LTE + 5G NR transmission) is sufficient, where the SAR exposure varies among SAR_{radio1} only, SAR_{radio2}, and SAR_{radio2} only scenarios.

The criteria to select a test configuration for validating Smart Transmit feature during SAR exposure switching scenarios is

- Select any two < 6GHz technologies/bands that the EUT supports simultaneous transmission (for example, LTE+5G NR).
- Among all supported simultaneous transmission configurations, the selection order is
 - 1. select one configuration where both P_{limit} of radio1 and radio2 is less than their corresponding P_{max} , preferably, with different P_{limits} . If this configuration is not available, then,
 - 2. select one configuration that has P_{limit} less than its P_{max} for at least one radio. If this can not be found, then,
 - 3. select one configuration that has P_{limit} of radio1 and radio2 greater than P_{max} but with least ($P_{limit} P_{max}$) delta.

Test for one simultaneous transmission scenario is sufficient as the feature operation is the same.

3.3 Test procedures for conducted power measurements

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 2. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

3.3.1 Time-varying Tx power transmission scenario

This test is performed with the two pre-defined test sequences described in Section 3.1 for all the technologies and bands selected in Section 3.2.1. The purpose of the test is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged SAR (corresponding time-averaged Tx power) does not exceed the FCC limit at all times (see Eq. (1a) and (1b)).

Test procedure

- 1. Measure P_{max} , measure P_{limit} and calculate $P_{reserve}$ (= measured P_{limit} in dBm $Reserve_power_margin$ in dB) and follow Section 3.1 to generate the test sequences for all the technologies and bands selected in Section 3.2.1. Both test sequence 1 and test sequence 2 are created based on measured P_{max} and measured P_{limit} of the EUT. Test condition to measure P_{max} and P_{limit} is:
 - \square Measure P_{max} with Smart Transmit <u>disabled</u> and callbox set to request maximum power.
 - Measure P_{limit} with Smart Transmit <u>enabled</u> and Reserve_power_margin set to 0 dB, callbox set to request maximum power.
- 2. Set Reserve_power_margin to actual (intended) value (3dB for this EUT based on Part 1 report) and reset power on EUT to enable Smart Transmit, establish radio link in desired radio configuration, with callbox requesting the EUT's Tx power to be at pre-defined test sequence 1, measure and record Tx power versus time, and then convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (1a)) using measured P_{limit} from above Step 1. Perform running time average to determine time-averaged power and 1gSAR or 10gSAR versus time as illustrated in Figure 3-1 where using 100-seconds time window as an example.
 - **NOTE:** In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.
 - **NOTE:** For an easier computation of the running time average, 0 dBm can be added at the beginning of the test sequences the length of the responding time window, for example, add 0dBm for 100-seconds so the running time average can be directly performed starting with the first 100-seconds data using excel spreadsheet. This technique applies to all tests performed in this Part 2 report for easier time-averaged computation using excel spreadsheet.



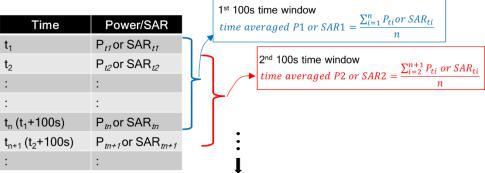


Figure 3-1 100s running average illustration

- 3. Make one plot containing:
 - Instantaneous Tx power versus time measured in Step 2,
 - b. Requested Tx power used in Step 2 (test sequence 1),
 - c. Computed time-averaged power versus time determined in Step 2.
 - d. Time-averaged power limit (corresponding to FCC SAR limit of 1.6 W/kg for 1gSAR or 4.0W/kg for 10gSAR) given by

Time avearged power limit = meas.
$$P_{limit} + 10 \times \log(\frac{FCC SAR \ limit}{meas.SAR \ Plimit})$$
 (5a)

where meas. P_{limit} and meas. SAR_Plimit correspond to measured power at P_{limit} and measured SAR at P_{limit} .

- 4. Make another plot containing:
 - a. Computed time-averaged 1gSAR or 10gSAR versus time determined in Step 2
 - b. FCC 1gSAR_{limit} of 1.6W/kg or FCC 10gSAR_{limit} of 4.0W/kg.
- 5. Repeat Steps 2 ~ 4 for pre-defined test sequence 2 and replace the requested Tx power (test sequence 1) in Step 2 with test sequence 2.
- 6. Repeat Steps 2 ~ 5 for all the selected technologies and bands.

The validation criteria are, at all times, the time-averaged power versus time shown in Step 3 plot shall not exceed the time-averaged power limit (defined in Eq. (5a)), in turn, the time-averaged 1gSAR or 10gSAR versus time shown in Step 4 plot shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (1b)).

3.3.2 Change in call scenario

This test is to demonstrate that Smart Transmit feature accurately accounts for the past Tx powers during time-averaging when a new call is established.

The call disconnect and re-establishment needs to be performed during power limit enforcement, i.e., when the EUT's Tx power is at $P_{reserve}$ level, to demonstrate the continuity of RF exposure management and limiting in call change scenario. In other words, the RF exposure averaged over any FCC defined time window (including the time

windows containing the call change) doesn't exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

Test procedure

- 1. Measure P_{limit} for the technology/band selected in Section 3.2.2. Measure P_{limit} with Smart Transmit <u>enabled</u> and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
- Set Reserve_power_margin to actual (intended) value and reset power on EUT to enable Smart Transmit.
- 3. Establish radio link with callbox in the selected technology/band.
- 4. Request EUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting EUT's Tx power to be at maximum power for about ~60 seconds, and then drop the call for ~10 seconds. Afterwards, reestablish another call in the same radio configuration (i.e., same technology/band/channel) and continue callbox requesting EUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time. Once the measurement is done, extract instantaneous Tx power versus time, convert the measured conducted Tx power into 1gSAR or 10gSAR value using Eq. (1a), and then perform the running time average to determine time-averaged power and 1gSAR or 10gSAR versus time.

NOTE: In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

- 5. Make one plot containing: (a) instantaneous Tx power versus time, (b) requested power, (c) computed time-averaged power, (d) time-averaged power limit calculated using Eq.(5a).
- 6. Make another plot containing: (a) computed time-averaged 1gSAR or 10gSAR versus time, and (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The validation criteria are, at all times, the time-averaged power versus time shall not exceed the time-averaged power limit (defined in Eq.(5a)), in turn, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (1b)).

3.3.3 Change in technology and band

This test is to demonstrate the correct power control by Smart Transmit during technology switches and/or band handovers.

Similar to the change in call test in Section 3.3.2, to validate the continuity of RF exposure limiting during the transition, the technology and band handover needs to be performed when EUT's Tx power is at $P_{reserve}$ level (i.e., during Tx power enforcement) to make sure that the EUT's Tx power from previous $P_{reserve}$ level to the new $P_{reserve}$ level

(corresponding to new technology/band). Since the P_{limit} could vary with technology and band, Eq. (1a) can be written as follows to convert the instantaneous Tx power in 1gSAR or 10gSAR exposure for the two given radios, respectively:

$$1g_or_10gSAR_1(t) = \frac{conducted_Tx_power_1(t)}{conducted_Tx_power_P_{limit_1}} * 1g_or_10gSAR_P_{limit_1}$$
 (6a)

$$1g_or_10gSAR_2(t) = \frac{conducted_Tx_power_2(t)}{conducted_Tx_power_P_{limit_2}} * 1g_or_10gSAR_P_{limit_2}$$
 (6b)

$$\frac{1}{T_{SAR}} \left[\int_{t-T_{SAR}}^{t_1} \frac{1g_or_10gSAR_1(t)}{FCC\ SAR\ limit} dt + \int_{t-T_{SAR}}^{t} \frac{1g_or_10gSAR_2(t)}{FCC\ SAR\ limit} dt \right] \le 1 \tag{6c}$$

where, <code>conducted_Tx_power_1(t)</code>, <code>conducted_Tx_power_P_limit_1</code>, and <code>1g_or_10gSAR_P_limit_1</code> correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at <code>P_limit</code>, and measured <code>1gSAR</code> or <code>10gSAR</code> value at <code>P_limit</code> of technology1/band1; <code>conducted_Tx_power_2(t)</code>, <code>conducted_Tx_power_P_limit_2(t)</code>, and <code>1g_or_10gSAR_P_limit_2</code> correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at <code>P_limit</code>, and measured <code>1gSAR</code> or <code>10gSAR</code> value at <code>P_limit</code> of technology2/band2. Transition from technology1/band1 to the technology2/band2 happens at time-instant ' t_1 '.

Test procedure

- Measure P_{limit} for both the technologies and bands selected in Section 3.2.3.
 Measure P_{limit} with Smart Transmit <u>enabled</u> and Reserve_power_margin set to 0 dB, callbox set to request maximum power.
- Set Reserve_power_margin to actual (intended) value and reset power on EUT to enable Smart Transmit
- 3. Establish radio link with callbox in first technology/band selected.
- 4. Request EUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting EUT's Tx power to be at maximum power for about ~60 seconds, and then switch to second technology/band selected. Continue with callbox requesting EUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time for the full duration of the test.
- 5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value using Eq. (6a) and (6b) and corresponding measured P_{limit} values from Step 1 of this section. Perform the running time average to determine time-averaged power and 1gSAR or 10gSAR versus time.
 - **NOTE:** In Eq.(6a) & (6b), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.
- 6. Make one plot containing: (a) instantaneous Tx power versus time, (b) requested power, (c) computed time-averaged power, (d) time-averaged power limit calculated using Eq.(5a).

 Make another plot containing: (a) computed time-averaged 1gSAR or 10gSAR versus time, and (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (6c)).

3.3.4 Change in antenna

This test is to demonstrate the correct power control by Smart Transmit during antenna switches from one antenna to another. The test procedure is identical to Section 3.3.3, by replacing technology/band switch operation with antenna switch. The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

NOTE: If the EUT does not support antenna switch within the same technology/band, but has multiple antennas to support different frequency bands, then the antenna switch test is included as part of change in technology and band (Section 3.3.3) test.

3.3.5 Change in DSI

This test is to demonstrate the correct power control by Smart Transmit during DSI switches from one DSI to another. The test procedure is identical to Section 3.3.3, by replacing technology/band switch operation with DSI switch. The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

3.3.6 Change in time window

This test is to demonstrate the correct power control by Smart Transmit during the change in averaging time window when a specific band handover occurs. FCC specifies time-averaging windows of 100s for Tx frequency < 3GHz, and 60s for Tx frequency between 3GHz and 6GHz.

To validate the continuity of RF exposure limiting during the transition, the band handover test needs to be performed when EUT handovers from operation band less than 3GHz to greater than 3GHz and vice versa. The equations (3a) and (3b) in Section 2 can be written as follows for transmission scenario having change in time window,

$$1gSAR_{1}(t) = \frac{conducted_Tx_power_1(t)}{conducted_Tx_power_P_{limit_1}} * 1g_or \ 10g_SAR_P_{limit_1}$$
 (7a)

$$1gSAR_{2}(t) = \frac{conducted_Tx_power_2(t)}{conducted_Tx_power_P_{limit_2}} * 1g_or \ 10g_SAR_P_{limit_2}$$
 (7b)

$$\frac{1}{T1_{SAR}} \left[\int_{t-T1_{SAR}}^{t_1} \frac{1g_or\ 10g_SAR_1(t)}{FCC\ SAR\ limit} dt \right] + \frac{1}{T2_{SAR}} \left[\int_{t-T2_{SAR}}^{t} \frac{1g_or\ 10g_SAR_2(t)}{FCC\ SAR\ limit} dt \right] \leq 1 \tag{7c}$$

where, $conducted_Tx_power_1(t)$, $conducted_Tx_power_P_{limit_1}(t)$, and $1g_or_1$ or $10g_or_2$ SAR P_{limit_1} correspond to the instantaneous Tx power, conducted Tx power at

 P_{limit} , and compliance $1g_{or} 10g_{SAR}$ values at P_{limit_1} of band1 with time-averaging window ' $T1_{SAR}$ '; $conducted_{Tx_power_2}(t)$, $conducted_{Tx_power_P_{limit_2}}(t)$, and $1g_{or} 10g_{SAR_P_{limit_2}}$ correspond to the instantaneous Tx power, conducted Tx power at P_{limit} , and compliance $1g_{or} 10g_{SAR}$ values at P_{limit_2} of band2 with time-averaging window ' $T2_{SAR}$ '. One of the two bands is less than 3GHz, another is greater than 3GHz. Transition from first band with time-averaging window ' $T1_{SAR}$ ' to the second band with time-averaging window ' $T2_{SAR}$ ' happens at time-instant ' t_1 '.

Test procedure

- 8. Measure P_{limit} for both the technologies and bands selected in Section 3.2.6. Measure P_{limit} with Smart Transmit <u>enabled</u> and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
- 9. Set Reserve_power_margin to actual (intended) value and enable Smart Transmit

Transition from 100s time window to 60s time window, and vice versa

- 10. Establish radio link with callbox in the technology/band having 100s time window selected in Section 3.2.6.
- 11. Request EUT's Tx power to be at 0 dBm for at least 100 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~140 seconds, and then switch to second technology/band (having 60s time window) selected in Section 3.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for about ~60s in this second technology/band, and then switch back to the first technology/band. Continue with callbox requesting EUT's Tx power to be at maximum power for at least another 100s. Measure and record Tx power versus time for the entire duration of the test.
- 12. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (7a) and (7b)) using corresponding technology/band Step 1 result, and then perform 100s running average to determine time-averaged 1gSAR or 10gSAR versus time. Note that in Eq.(7a) & (7b), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the worst-case 1gSAR or 10gSAR value tested in Part 1 for the selected technologies/bands at P_{limit} .
- 13. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 4.
- 14. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 5, (b) computed time-averaged 1gSAR versus time determined in Step 5, and (c) corresponding regulatory 1gSAR_{limit} of 1.6W/kg or 10gSAR_{limit} of 4.0W/kg.

Transition from 60s time window to 100s time window, and vice versa

- 15. Establish radio link with callbox in the technology/band having 60s time window selected in Section 3.2.6.
- 16. Request EUT's Tx power to be at 0 dBm for at least 60 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~80 seconds, and then switch to second technology/band (having 100s time window) selected in Section 3.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for about ~100s in this second technology/band, and then switch back to the

first technology/band. Continue with callbox requesting EUT's Tx power to be at maximum power for the remaining time for a total test time of 500 seconds. Measure and record Tx power versus time for the entire duration of the test.

17. Repeat above Step 5~7 to generate the plots

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory 1gSAR_{limit} of 1.6W/kg or 10gSAR_{limit} of 4.0W/kg

3.3.7 SAR exposure switching

This test is to demonstrate that Smart Transmit feature is accurately accounts for switching in exposures among SAR from radio1 only, SAR from both radio1 and radio2, and SAR from radio2 only scenarios, and ensures total time-averaged RF exposure complies with the FCC limit. Here, radio1 represents primary radio (for example, LTE anchor in a NR non-standalone mode call) and radio2 represents secondary radio (for example, 5G NR or mmW NR). The detailed test procedure for SAR exposure switching in the case of LTE+5G NR non-standalone mode transmission scenario is provided in Appendix B.2.

Test procedure:

- 1. Measure conducted Tx power corresponding to P_{limit} for radio1 and radio2 in selected band. Test condition to measure conducted P_{limit} is:
 - □ Establish device in call with the callbox for radio1 technology/band. Measure conducted Tx power corresponding to radio1 P_{limit} with Smart Transmit enabled and Reserve_power_margin set to 0 dB, callbox set to request maximum power.
 - □ Repeat above step to measure conducted Tx power corresponding to radio2 Plimit. If radio2 is dependent on radio1 (for example, non-standalone mode of 5G NR requiring radio1 LTE as anchor), then establish radio1 + radio2 call with callbox, and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from radio2 5G NR, measured conducted Tx power corresponds to radio2 Plimit (as radio1 LTE is at all-down bits)
- 2. Set Reserve_power_margin to actual (intended) value, with EUT setup for radio1 + radio2 call. In this description, it is assumed that radio2 has lower priority than radio1. Establish device in radio1+radio2 call, and request all-down bits or low power on radio1, with callbox requesting EUT's Tx power to be at maximum power in radio2 for at least one time window. After one time window, set callbox to request EUT's Tx power to be at maximum power on radio1, i.e., all-up bits. Continue radio1+radio2 call with both radios at maximum power for at least one time window, and drop (or request all-down bits on) radio2. Continue radio1 at maximum power for at least one time window. Record the conducted Tx power for both radio1 and radio2 for the entire duration of this test.
- 3. Once the measurement is done, extract instantaneous Tx power versus time for both radio1 and radio2 links. Convert the conducted Tx power for both these radios into 1gSAR or 10gSAR value (see Eq. (6a) and (6b)) using corresponding

technology/band P_{limit} measured in Step 1, and then perform the running time average to determine time-averaged 1gSAR or 10gSAR versus time.

- 4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
- 5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory 1gSAR_{limit} of 1.6W/kg or 10gSAR_{limit} of 4.0W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory 1gSAR_{limit} of 1.6W/kg or 10gSAR_{limit} of 4.0W/kg.

3.4 Test procedure for time-varying SAR measurements

This section provides general time-varying SAR measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 2. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

To perform the validation through SAR measurement for transmission scenario 1 described in Section 2, the "path loss" between callbox antenna and EUT needs to be calibrated to ensure that the EUT Tx power reacts to the requested power from callbox in a radiated call. It should be noted that when signaling in closed loop mode, protocollevel power control is in play, resulting in EUT not solely following callbox TPC (Tx power control) commands. In other words, EUT response has many dependencies (RSSI, quality of signal, path loss variation, fading, etc.,) other than just TPC commands. These dependencies have less impact in conducted setup (as it is a controlled environment and the path loss can be very well calibrated) but have significant impact on radiated testing in an uncontrolled environment, such as SAR test setup. Therefore, the deviation in EUT Tx power from callbox requested power is expected, however the time-averaged SAR should not exceed FCC SAR requirement at all times as Smart Transmit controls Tx power at EUT.

The following steps are for time averaging feature validation through SAR measurement:

- 1. "Path Loss" calibration: Place the EUT against the phantom in the worst-case position determined based on Section 3.2.1. For each band selected, prior to SAR measurement, perform "path loss" calibration between callbox antenna and EUT. Since the SAR test environment is not controlled and well calibrated for OTA (Over the Air) test, extreme care needs to be taken to avoid the influence from reflections. The test setup is described in Section 7.1.
- 2. Time averaging feature validation:
 - i For a given radio configuration (technology/band) selected in Section 3.2.1, enable Smart Transmit and set *Reserve_power_margin* to 0 dB, with callbox to request maximum power, perform area scan, conduct pointSAR measurement at peak location of the area scan. This point SAR value, *pointSAR_Plimit*, corresponds to point SAR at the measured *Plimit* (i.e., measured *Plimit* from the EUT in Step 1 of Section 3.3.1).
 - ii Set Reserve_power_margin to actual (intended) value and reset power on EUT to enable Smart Transmit. Note, if Reserve_power_margin cannot be set

wirelessly, care must be taken to re-position the EUT in the exact same position relative to the SAM phantom as in above Step 2.i. Establish radio link in desired radio configuration, with callbox requesting the EUT's Tx power at power levels described by test sequence 1 generated in Step 1 of Section 3.3.1, conduct point SAR measurement versus time at peak location of the area scan determined in Step 2.i of this section. Once the measurement is done, extract instantaneous point SAR vs time data, pointSAR(t), and convert it into instantaneous 1gSAR or 10gSAR vs. time using Eq. (3a), re-written below:

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_P_{limit}} * 1g_or_10gSAR_P_{limit}$$

where, $pointSAR_P_{limit}$ is the value determined in Step 2.i, and pointSAR(t) is the instantaneous point SAR measured in Step 2.ii, $1g_or_10gSAR_P_{limit}$ is the measured 1gSAR or 10gSAR value listed in Part 1 report.

- iii Perform 100s running average to determine time-averaged 1gSAR or 10gSAR versus time.
- iv Make one plot containing: (a) time-averaged 1gSAR or 10gSAR versus time determined in Step 2.iii of this section, (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.
- v Repeat 2.ii ~ 2.iv for test sequence 2 generated in Step 1 of Section 3.3.1.
- vi Repeat 2.i ~ 2.v for all the technologies and bands selected in Section 3.2.1.

The time-averaging validation criteria for SAR measurement is that, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (3b)).



4 Test Configurations

4.1 WWAN (sub-6) transmission

The Plimit values, corresponding to SAR_design_target, for technologies and bands supported by EUT are derived in Part 0 report and summarized in Table 4-1. Note all P_{limit} power levels entered in Table 4-1 correspond to average power levels after accounting for duty cycle in the case of TDD modulation schemes (for e.g., GSM, LTE TDD & 5G NR TDD).

For EFS version 16 (or higher), secondary radio (5G mmW NR) can get up to 100% reserve factor irrespective of reserve_power_margin setting. So, in the below analysis, replace 75% with 100% reserve factor in case of EFS version 16 (or higher).

Table 4-1: Plimit for supported technologies and bands (Plimit in EFS file)

				FCC SAR	-Plimit				
Band	Antenna	Head DSI 2 Standalone Power	Head DSI 2 Simultaneous	Body Worn DSI 3 Standalone Power	Body Worn & Hotspot DSI 3 Simultaneous	Extremely DSI6 Standalone Power	Extremely DSI6 Simultaneous	Sensor Off DSI4	Pamx
GSM850 GPRS_2TX	Ant 1	30.9	29.6	24.5	23.7	25.6	24.1	25.0	25.0
GSM1900 GPRS_2TX	Ant 1	34.3	33	16.3	13.2	20	18.5	21.0	21.0
WCDMA II	Ant 1	31	29.7	16.5	13	20	18.5	23.0	23.0
WCDMA VI	Ant 1	31.4	30.1	17.1	14.2	19.7	18.2	23.0	23.0
WCDMA V	Ant 1	27.6	26.3	23	21.4	23.2	21.7	23.0	23.0
WCDMA V	Ant 2	23	21.7	23	22.5	26.5	25.0	23.0	23.0
LTE 2	Ant 1	31.7	30.4	15.7	13.2	19.5	19.0	23.0	23.0
LTE 7	Ant 1	31.8	30.5	20	15.8	22.3	20.8	23.0	23.0
LTE 7	Ant 2	19.4	18.1	23	21.6	24.5	23.0	23.0	23.0
LTE 12 (17)	Ant 1	33.8	32.5	27	25.7	23.0	23.0	23.0	23.0
LTE 12 (17)	Ant 2	23.2	21.9	24.4	23.1	23.0	23.0	23.0	23.0
LTE 13	Ant 1	31.3	30	25.1	23.8	23.0	23.0	23.0	23.0
LTE 26 (5)	Ant 1	29.5	28.2	23	22.7	24.5	23.0	23.0	23.0
LTE 26 (5)	Ant 2	23	21.7	23.2	22.5	26.8	25.3	23.0	23.0
LTE 66 (4)	Ant 1	31.2	29.9	17.3	14.4	20.1	18.6	23.0	23.0
LTE 66 (4)	Ant 2	18.1	16.8	18.4	15.6	21.5	20.0	23.0	23.0
LTE 38 Power Class3	Ant 1	31.4	30.1	20.4	16.6	22.6	21.1	22.4	21.0
LTE 38 Power Class2	Ant 1	31.4	30.1	20.4	16.6	22.6	21.1	22.4	22.4
LTE 41 Power Class3	Ant 1	31.4	30.1	20.4	16.6	22.6	21.1	22.4	21.0
LTE 41 Power Class2	Ant 1	31.4	30.1	20.4	16.6	22.6	21.1	22.4	22.4
LTE 42	Ant 4	17	15.7	20.6	16	19.7	18.2	22.0	22.0
FR1 n5	Ant 1	30	28.7	24	22.6	23.0	23.0	23.0	23.0
FR1 n5	Ant 2	22.4	21.1	23.7	22.7	23.0	23.0	23.0	23.0
FR1 n7	Ant 1	34.1	32.8	21.7	17	23.8	22.3	23.0	23.0
FR1 n7	Ant 2	20	18.7	23.2	21	25.4	23.9	23.0	23.0
FR1 n38	Ant 1	35.2	33.9	20.4	16.6	22.5	21.0	23.0	23.0
FR1 n38	Ant 2	19.2	17.9	21.8	21	23.0	23.0	23.0	23.0
FR1 n66	Ant 1	33.2	31.9	17.3	15.1	20	18.5	23.0	23.0
N FR1 n66	Ant 2	19.3	18	19.5	16	21.4	19.9	22.0	22.0
FR1 n77 (78)	Ant 4	16.6	15.3	19.2	14.9	18.5	17.0	23.0	23.0



*Pmax is used for RF tune up procedure. The maximum allowed output power is equal to Pmax + device uncertainty.

**All Plimit power levels entered in the Table correspond to average power levels after accounting for duty cycle in the case TDD modulation schemes (for e.g., GSM & LTE TDD & NR TDD).

Based on selection criteria described in Section 3.2.1, the selected technologies/bands for testing time-varying test sequences are listed in Table 4-3, the Reserve power margin (dB) for IHDT56AC1 is set to 3dB in EFS, and is used in Part 2 test.

The radio configurations used in Part 2 test for selected technologies, bands, DSIs and antennas are listed in Table 4-3. The corresponding worst-case radio configuration 1gSAR or 10gSAR values for selected technology/band/DSI are extracted from Part 1 report and are listed in the last column of Table 4-3.

Based on equations (1a), (2a), (3a) and (4a), it is clear that Part 2 testing outcome is normalized quantity, which implies that it can be applied to any radio configuration within a selected technology/band/DSI. Thus, as long as applying the worst-case SAR obtained from the worst radio configuration in Part 1 testing to calculate time-varying SAR exposure in equations (1a), (2a), (3a) and (4a), the accuracy in compliance demonstration remains the same.

Trigger condition

Exposure co	Trigger Conditions	DSI	
Head	touch and tilt 15deg	Receiver on	DSI2
Body Worn /Hotspot	5 mm	Sensor On	DSI3
Body Worn / Sensor Off	5 mm	Sensor Off	DSI4
Extremity	0mm	Sensor On	DSI6
Extremity / Sensor Off	Sensor Trigger Distance -1mm	Sensor Off	DSI4



Table 4-2: Radio configurations selected for Part 2 test

Test case #	Test scenario	Tech	Band	Ant	DSI	Channel	Freq (MHz)	BW (MHz)	RB size	RB offset	mode	position	Position details	Part 1, SAR@Plimit 1-g SAR (W/kg)
1		GSM	1900	1	3	512	1850.2	-	-	-	GPRS (2 Tx)	Back	5mm	1
2		WCDMA	2	1	3	9400	1880	-	-	-	RMC 12.2Kbps	Back	5mm	0.935
3		WCDMA	4	1	3	1513	1752.6	ı	-	-	RMC 12.2Kbps	Back	5mm	1.14
4	Time-Varying transmission	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	1.05
5		LTE	42	4	3	42590	3500	20M	1	0	QPSK	Front	5mm	1.09
6		5G NR SA	38	2	3	519000	2595	40M	1	1	QPSK	Back	5mm	0.919
7		5G NR SA	77	4	2	656000	3840	100M	1	1	QPSK	Right Cheek	0mm	1.01
8	Call Drop	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	1.05
9	Tech/band switch	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	1.05
9	recipalid switch	WCDMA	2	1	3	9400	1880	ı	-	-	RMC 12.2Kbps	Back	5mm	0.935
10	DSI switch	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	1.05
10	DSI SWILCII	LTE	2	1	6	18700	1860	20M	1	0	QPSK	Back	5mm	2.37
11	Change in Time Window	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	1.05
''	(100-60-100s)	LTE	42	4	3	42590	3500	20M	1	0	QPSK	Front	5mm	1.09
40	Change in	LTE	42	4	3	42590	3500	20M	1	0	QPSK	Front	5mm	1.09
12	Time Window (60-100-60s)	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	1.05
40	UL CA	LTE	4	1	3	132322	1745	20M	1	0	QPSK	Back	5mm	0.863
13	SAR vs SAR	LTE	5	2	3	26865	831.5	15M	1	0	QPSK	Back	5mm	0.924
	EN-DC	LTE	7	1	2	21100	2535	20M	1	0	QPSK	Right Cheek	0mm	0.139
14	SAR vs SAR	5G NR NSA	78	4	2	656000	3840	100M	1	1	QPSK	Right Cheek	0mm	1.01
15	Wifi/BT Backoff	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	1.05

Note that the EUT has total six DSI states to manage the output power for different conditions, including five for the RF exposure conditions in above table 4-1, detail DSI states and trigger conditions shown on the operational description, the maximum 1gSAR/or 10gSAR among all exposure scenarios is used in Smart Transmit feature for time averaging operation.

Based on the selection criteria described in Section 3.2, the radio configurations for the Tx varying transmission test cases listed in Section 2 are:

- Technologies and bands for time-varying Tx power transmission: The test case 1~7 listed in Table 4-2 are selected to test with the test sequences defined in Section 3.1 in both time-varying conducted power measurement and time-varying SAR measurement.
- 2. Technology and band for change in call test: The test case 8 listed in Table 4-2 are selected for performing the call drop test in conducted power setup. LTE B2 having the lowest P_{limit} among all technologies and bands
- 3. <u>Technologies and bands for change in technology/band test</u>: The test case 9 listed in Table 4-2 is selected for handover test from a technology/band to another technology/band, in conducted power setup.
- 4. <u>Technologies and bands for change in DSI</u>: The test case 10 listed in Table 4-2 is selected for DSI switch test by establishing a call in LTE B2 in DSI=3, and then handing over to DSI = 6 exposure scenario in conducted power setup.
- 5. Technologies and bands for change in time-window/antenna: The test case 11~12 listed in Table 4-2 is selected for time window switch between 60s window (LTE B42) and 100s window (LTE B2) in conducted power setup. LTE B42 is using different antenna from LTE B2, so this test also address the antenna change.
- 6. Technologies and bands for switch in SAR exposure: The test case 13~14 listed in Table 4-2 are selected for SAR exposure switching test in one of the supported simultaneous WWAN transmission scenario, i.e., LTE + 5G NR active or LTE Inter-Band Uplink CA in the same 100s time window, in conducted power setup.
- 7. <u>Verification of WWAN Backoff When WiFi/BT is Transmitting</u>: The test case 15 is selected for performing the WiFi on / off test in conducted power setup. LTE B2 having the lowest Plimit among all technologies and bands.

5 Conducted Power Test Results for Sub-6 Smart Transmit Feature Validation

5.1 Measurement setup

The Rohde & Schwarz CMW500 callbox is used in this test. The test setup schematic are shown in Figures 6-1. For single antenna measurement, one port (RF1 COM) of the callbox is connected to the RF port of the EUT using a directional coupler. For antenna & technology switch measurement, two ports (RF1 COM and RF3 COM) of the callbox used for signaling two different technologies are connected to a combiner, which is in turn connected to a directional coupler. The other end of the directional coupler is connected to a splitter to connect to two RF ports of the EUT corresponding to the two antennas of interest. In both the setups, power meter is used to tap the directional coupler for measuring the conducted output power of the EUT. For time averaging validation test (Section 3.3.1), call drop test (Section 3.3.2), and DSI switch test (Section 3.3.4), only RF1 COM port of the callbox is used to communicate with the EUT. For technology/band switch measurement (Section. 3.3.3), both RF1 COM and RF3 COM port of callbox are used to switch from one technology communicating on RF1 COM port to another technology communicating on RF3 COM port. All the path losses from RF port of EUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

Sub6 NR test setup:

The Keysight UXME7515B callbox is used in this test. The test setup schematic are shown in Figures 6-1. For single antenna measurement, one port (RF1 COM) of the callbox is connected to the RF port of the EUT using a directional coupler.

LTE+5G NR test setup:

The Keysight UXME7515B callbox is used in this test. If LTE conducted port and 5G NR conducted port are same on this EUT (i.e., they share the same antenna), therefore, low-/high-pass filter are used to separate LTE and 5G NR signals for power meter measurement via directional couplers, as shown in below Figure 6-1 C (Appendix F – Test Setup Photo).

All the path losses from RF port of DUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.



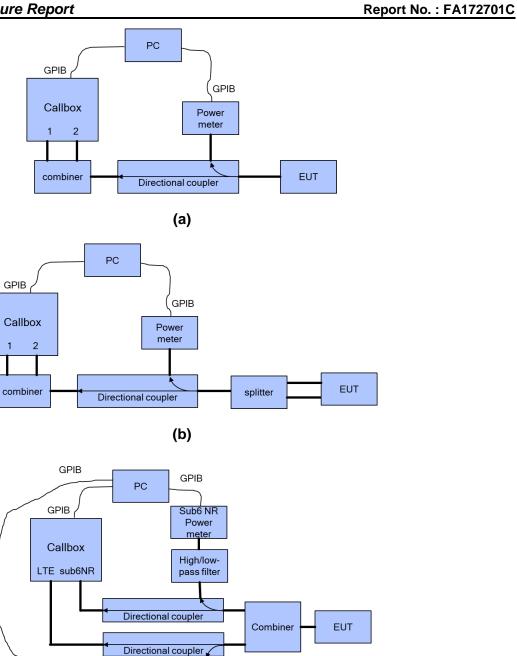


Figure 5-1 Conducted power measurement setup

(c)

Low/high-

pass filter

LTE

Power

Both the callbox and power meter are connected to the PC using GPIB cables. Two test scripts are custom made for automation, and the test duration set in the test scripts is 500 seconds.

For time-varying Tx power measurement, the PC runs the 1st test script to send GPIB commands to control the callbox's requested power versus time, while at the same time to record the conducted power measured at EUT RF port using the power meter. The commands sent to the callbox to request power are:

- 0dBm for 100 seconds
- test sequence 1 or test sequence 2 (defined in Section 3.1 and generated in Section 3.2.1), for 360 seconds
- stay at the last power level of test sequence 1 or test sequence 2 for the remaining time.

Power meter readings are periodically recorded every 100ms. A running average of this measured Tx power over 100 seconds is performed in the post-data processing to determine the 100s-time averaged power.

For call drop, technology/band/antenna switch, and DSI switch tests, after the call is established, the callbox is set to request the EUT's Tx power at 0dBm for 100 seconds while simultaneously starting the 2^{nd} test script runs at the same time to start recording the Tx power measured at EUT RF port using the power meter. After the initial 100 seconds since starting the Tx power recording, the callbox is set to request maximum power from the EUT for the rest of the test. Note that the call drop/re-establish, or technology/band/antenna switch or DSI switch is manually performed when the Tx power of EUT is at $P_{reserve}$ level. See Section 3.3 for detailed test procedure of call drop test, technology/band/antenna switch test and DSI switch test.

5.2 Plimit and Pmax measurement results

The measured P_{limit} for all the selected radio configurations given in Table 4-2 are listed in below Table 5-1. P_{max} was also measured for radio configurations selected for testing time-varying Tx power transmission scenarios in order to generate test sequences following the test procedures in Section 3.1.

Table 5-1: Measured P_{limit} and P_{max} of selected radio configurations

Test case #	Test scenario	Tech	Band	Ant	DSI	Channel	Freq (MHz)	BW (MHz)	RB size	RB offset	mode	position	Position details	Plimit EFS setting(dBm)	target pmax (dBm)	measured plimit (dBm)	measured pmax (dBm)
1		GSM	1900	1	3	512	1850.2	•	-	-	GPRS (2 Tx)	Back	5mm	16.3	21	16.3	21.9
2		WCDMA	2	1	3	9400	1880	i	-	-	RMC 12.2Kbps	Back	5mm	16.5	23	16.07	23.9
3	Time-Varying	WCDMA	4	1	3	1513	1752.6	ı	-	-	RMC 12.2Kbps	Back	5mm	17.1	23	17	23.7
4	transmission	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	15.7	23	15.45	24
5		LTE	42	4	3	42590	3500	20M	1	0	QPSK	Front	5mm	20.6	22	20.3	22.6
6		5G NR SA	38	2	3	519000	2595	40M	1	1	QPSK	Back	5mm	21.8	23	21	23.1
7		5G NR SA	77	4	2	656000	3840	100M	1	1	QPSK	Right Cheek	0mm	16.6	23	16.7	23.2
8	Call Drop	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	15.7	23	15.45	24
1_	Tech/band	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	15.7	23	15.45	24
9	switch	WCDMA	2	1	3	9400	1880	i	-	-	RMC 12.2Kbps	Back	5mm	16.5	23	16.07	23.9
10	DSI switch	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	15.7	23	15.45	24
10		LTE	2	1	6	18700	1860	20M	1	0	QPSK	Back	5mm	19.5	23	19.2	24
11	Change in Time Window	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	15.7	23	15.45	24
''	(100-60-100s)	LTE	42	4	3	42590	3500	20M	1	0	QPSK	Front	5mm	20.6	22	20.3	22.6
12	Change in Time Window	LTE	42	4	3	42590	3500	20M	1	0	QPSK	Front	5mm	20.6	22	20.3	22.6
12	(60-100-60s)	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	15.7	23	15.45	24
13	UL CA	LTE	4	1	3	132322	1745	20M	1	0	QPSK	Back	5mm	17	23	16.9	24
13	SAR vs SAR	LTE	5	2	3	26865	831.5	15M	1	0	QPSK	Back	5mm	23	23	24	24
14	EN-DC	LTE	7	1	2	21100	2535	20M	1	0	QPSK	Right Cheek	0mm	31.8	23	22.5	22.5
14	SAR vs SAR	5G NR NSA	78	4	2	656000	3840	100M	1	1	QPSK	Right Cheek	0mm	16.6	23	17.1	22.7
15	Wifi/BT Backoff	LTE	2	1	3	18700	1860	20M	1	0	QPSK	Back	5mm	15.7	23	15.45	24

Note: the device uncertainty of P_{max} is +1dB/-1dB as provided by manufacturer.

Issued Date: Oct. 18, 2021

5.3 Time-varying Tx power measurement results

The measurement setup is shown in Figures 6-1(a) and 6-1(c). The purpose of the time-varying Tx power measurement is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged Tx power when represented in time-averaged 1gSAR or 10gSAR values does not exceed FCC limit as shown in Eq. (1a) and (1b), rewritten below:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit}$$
(1a)

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^{t} \frac{1g_{o}r_{1} \log SAR(t)dt}{FCC_{SAR} limit} \le 1$$
(1b)

where, $conducted_Tx_power(t)$, $conducted_Tx_power_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured 1gSAR and 10gSAR values at P_{limit} reported in Part 1 test (listed in Table 4-2 of this report as well).

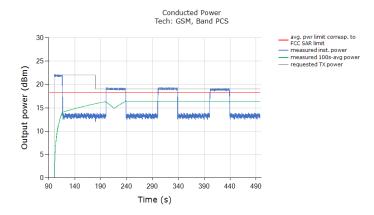
Following the test procedure in Section 3.3, the conducted Tx power measurement for all selected configurations are reported in this section. In all the conducted Tx power plots, the dotted line represents the requested power by callbox (test sequence 1 or test sequence 2), the blue curve represents the instantaneous conducted Tx power measured using power meter, the green curve represents time-averaged power and red line represents the conducted power limit that corresponds to FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

Similarly, in all the 1g or 10gSAR plots (when converted using Eq. (1a)), the green curve represents the 100s/60s-time averaged 1gSAR or 10gSAR value calculated based on instantaneous 1gSAR or 10gSAR; and the red line limit represents the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

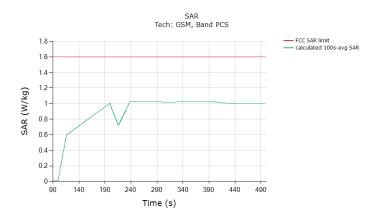


5.3.1 GSM1900

Test result for test sequence 1:



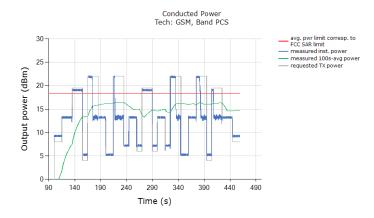
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



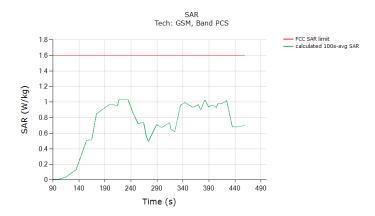
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.028
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB
device uncertainty	



Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6W/kg for 1gSAR:

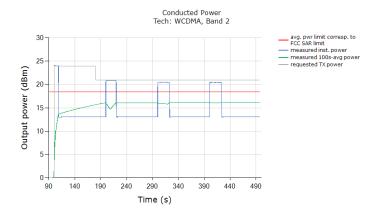


	(W/kg)				
FCC 1gSAR limit	1.6				
Max 100s-time averaged 1gSAR (green curve)	1.031				
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB					
device uncertainty					

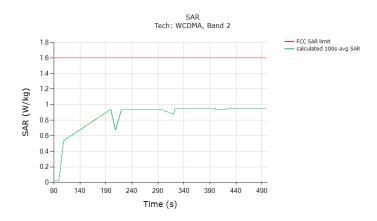


5.3.2 WCDMA B2

Test result for test sequence 1:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:

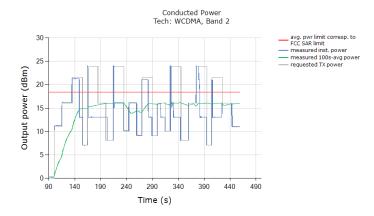


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.948
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB
device uncertainty	

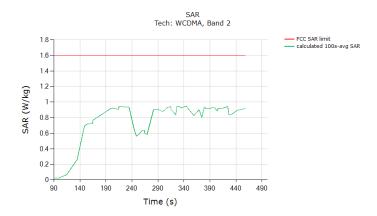


Report No.: FA172701C

Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:

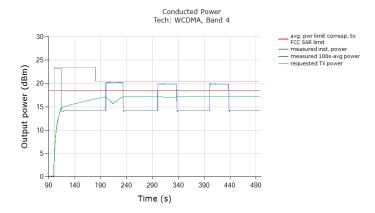


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.946
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB
device uncertainty	

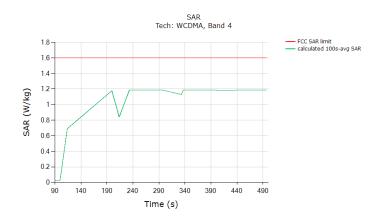


5.3.3 WCDMA Band 4

Test result for test sequence 1:



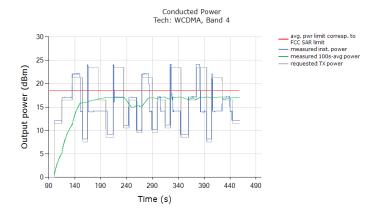
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



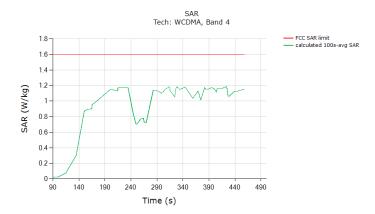
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 10gSAR (green curve)	1.188
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB device uncertainty	



Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:

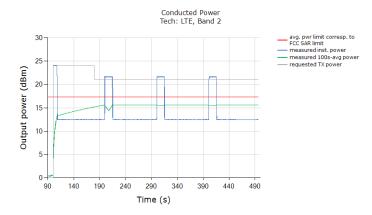


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.187
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	

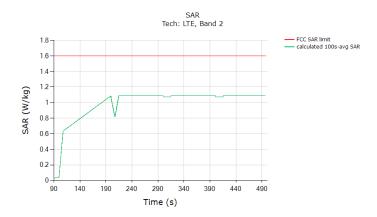


5.3.4 LTE B2

Test result for test sequence 1:



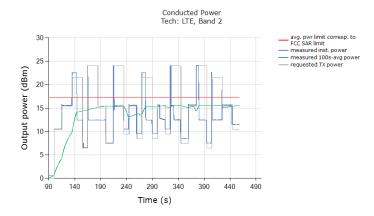
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



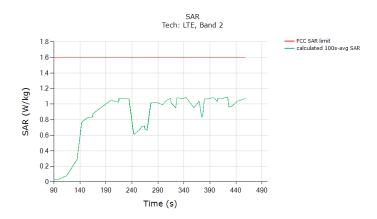
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 10gSAR (green curve)	1.091
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB device uncertainty	



Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:

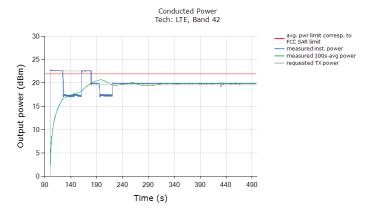


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.089
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	

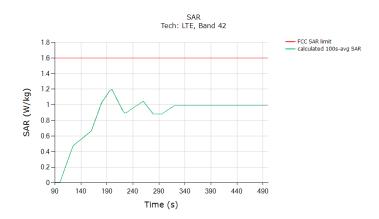


5.3.5 LTE B42

Test result for test sequence 1:



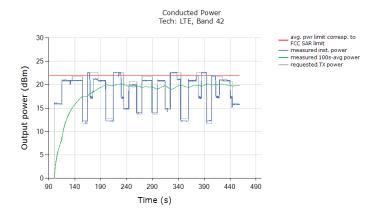
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



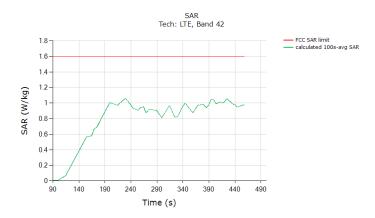
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.199
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	



Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:

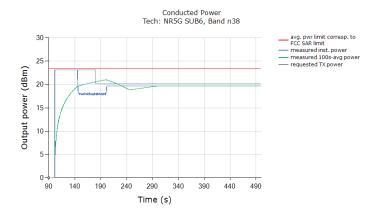


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.058
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	

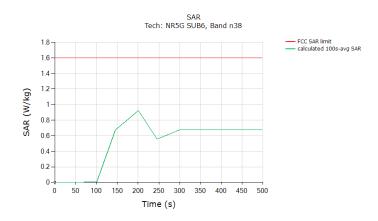
SPORTON LAB. FCC RF Exposure Report

5.3.6 5G NR Band 38

Test result for test sequence 1:



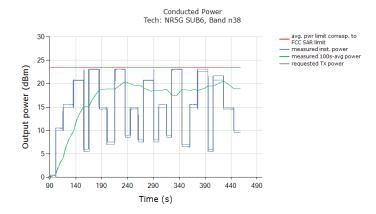
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



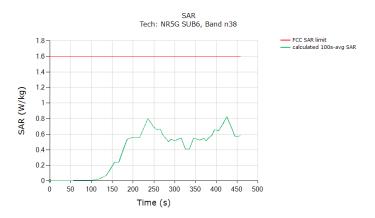
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.922
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	



Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:

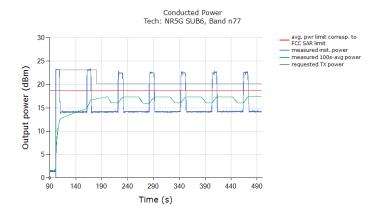


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.825
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	

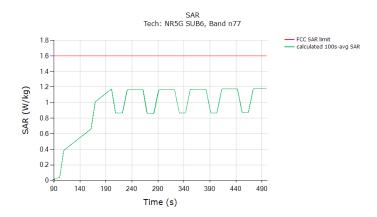
SPORTON LAB. FCC RF Exposure Report

5.3.7 5G NR Band 77

Test result for test sequence 1:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:

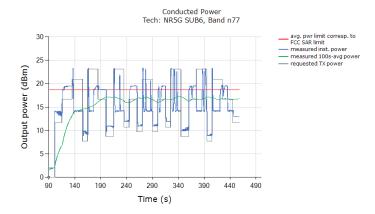


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.179
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	

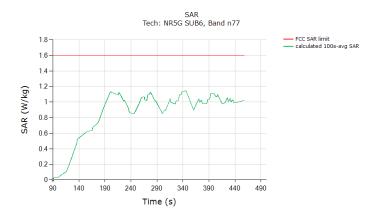
Issued Date: Oct. 18, 2021



Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



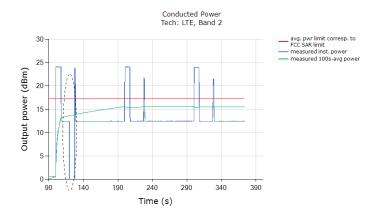
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.145
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB device uncertainty	

5.4 Change in Call Test Results

This test was measured with LTE B2, DSI=3, and with callbox requesting maximum power. The call drop was manually performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black region). The measurement setup is shown in Figure 6-1. The detailed test procedure is described in Section 3.3.2.

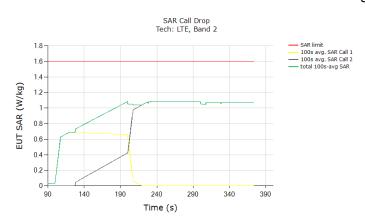
Call drop test result:

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power kept the same $P_{reserve}$ level of LTE B2 after the call was re-established:



Plot Notes: ... The conducted power plot shows expected Tx transition.

Plot 2: Above time-averaged conducted Tx power is converted/calculated into timeaveraged 1gSAR using Equation (1a) and plotted below to demonstrate that the timeaveraged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.082
Validated	

The test result validated the continuity of power limiting in call drop scenario.

Page 44

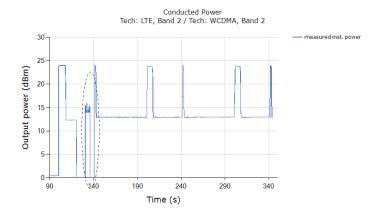
Issued Date: Oct. 18, 2021



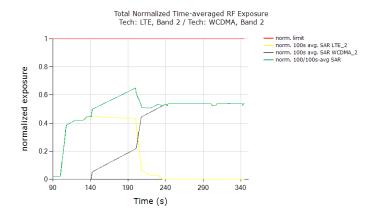
5.5 Change in technology/band test results

This test was conducted with callbox requesting maximum power, and with antenna & technology switch from LTE B2, DSI = 3 to WCDMA B2, DSI = 3. Following procedure detailed in Section 3.3.3, and using the measurement setup shown in Figure 6-1(a) and (c), the technology/band switch was performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black region).

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed from LTE B2, DSI = $3 P_{reserve}$ level to WCDMA B2, DSI = 3



Plot 2: All the time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-averaged normalized exposure versus time does not exceed the normalized FCC limit of 1.0:



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max 100s-time averaged normalized Exposure Ratio (green curve)	0.650
Validated	

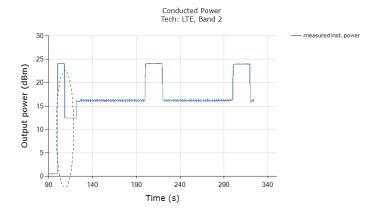
The test result validated the continuity of power limiting in technology/band switch scenario.

5.6 Change in DSI test results

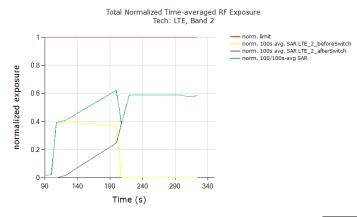
This test was conducted with callbox requesting maximum power, and with DSI switch from LTE B2 DSI=3 to DSI = 6. Following procedure detailed in Section 3.3.5 using the measurement setup shown in Figure 6-1(a) and (c), the DSI switch was performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black circle).

Test result for change in DSI:

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed when DSI=3 switches to DSI=6.



Plot 2: All the time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-averaged normalized Exposure versus time does not exceed the FCC limit of 1 unit.



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max 100s-time averaged normalized Exposure Ratio (green curve)	0.623
Validated	

The test result validated the continuity of power limiting in DSI switch scenario.

Page 46

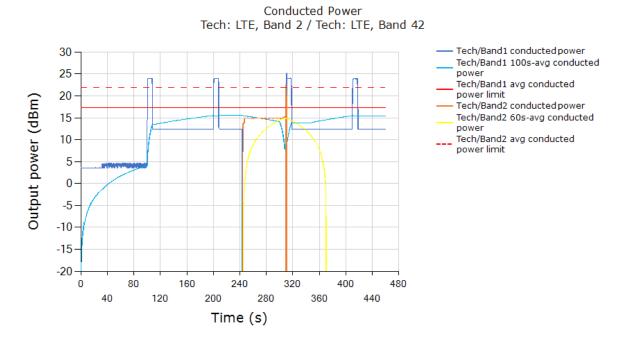


5.7 Change in Time window / antenna switch test results

5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2

Test result for change in time-window (from 100s to 60s to 100s):

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed when LTE B2 switches to LTE B42 (~245 seconds timestamp) and switches back to LTE Band 2 (~310 seconds timestamp):

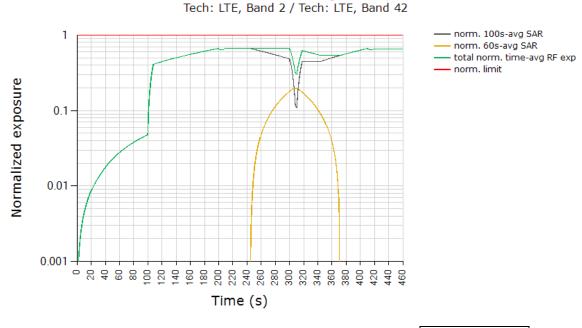


Plot Notes: The conducted power plot shows expected transitions in Tx power at ~245 seconds (100s-to-60s transition) and at ~310 seconds (60s-to-100s transition) in order to maintain total time-averaged RF exposure compliance across time windows, as show in next plot.

Report No.: FA172701C

Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the Tx power of device to obtain 100s-averaged normalized SAR in LTE B2 as shown in black curve. Similarly, equation (7b) is used to obtain 60s-averaged normalized SAR in LTE Band 42 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).

Total Normalized Time-averaged RF Exposure



	Exposure Ratio
FCC normalized Exposure Ratio	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.668
Validated	

Plot Notes:

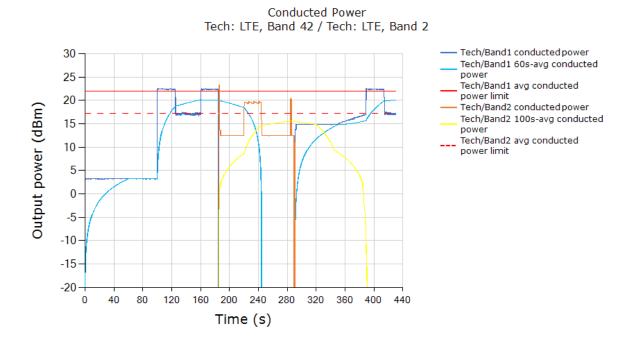
Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 100s-to-60s window at ~245s time stamp, and from 60s-to-100s window at ~310s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target +1dB device uncertainty. In this test, with a maximum normalized SAR of 0.668 being \leq 0.79 (=1/1.6 +1dB device uncertainty), the above test result validated the continuity of power limiting in time-window switch scenario.



5.7.2 Test case 2: transition from LTE B42 to LTE B2 (i.e., 60s to 100s), then back to LTE B42

Test result for change in time-window (from 60s to 100s to 60s):

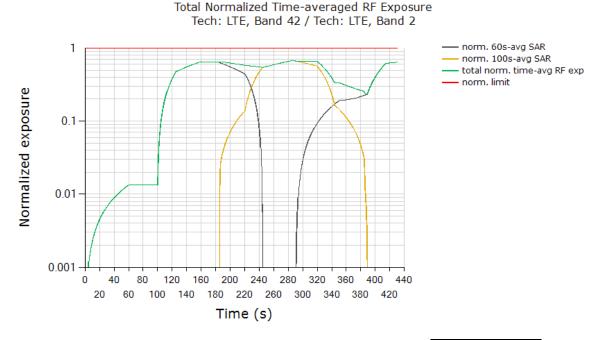
Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed when LTE Band 42 switches to LTE B2 (~185 seconds timestamp) and switches back to LTE B42 (~290 seconds timestamp):



Plot Notes: The conducted power plot shows expected transitions in Tx power at ~185 seconds (60s-to-100s transition) and at ~290 seconds (100s-to-60s transition) in order to maintain total time-averaged RF exposure compliance across time windows, as show in next plot.

Report No. : FA172701C

Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the Tx power of device to obtain 60s-averaged normalized SAR in LTE B42 as shown in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in LTE B2 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



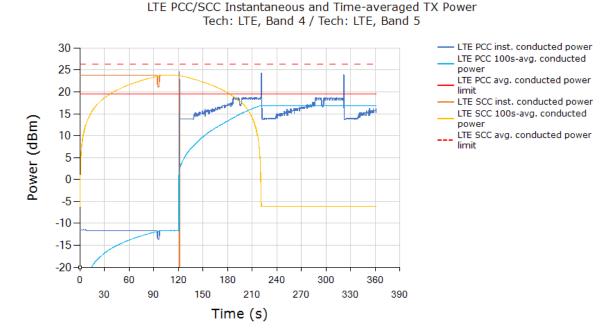
	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.679
Validated	

Plot Notes:

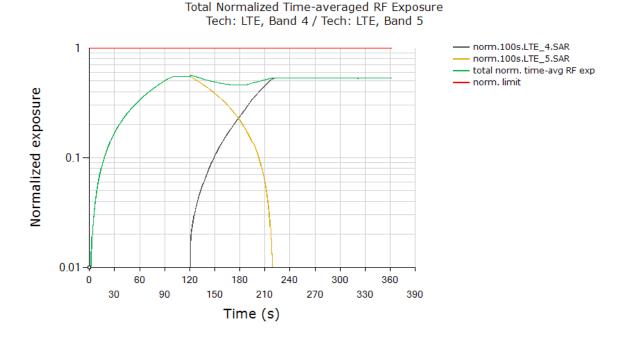
Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 60s-to-100s window at ~185s time stamp, and from 100s-to-60s window at ~290s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target +1dB device uncertainty. In this test, with a maximum normalized SAR of 0.679 being \leq 0.79 (=1/1.6 +1dB device uncertainty), the above test result validated the continuity of power limiting in time-window switch scenario.

5.8 Switch in SAR exposure test results (LTE Inter-Band Uplink CA)

This test was conducted with callbox requesting maximum power, and with the EUT in LTE UL CA B4 + LTE UL CA B5 call. Following procedure detailed in Section 3.3.7 and Appendix C, and using the measurement setup shown in Figure 4-1, the SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios.



Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (6a) is used to convert the LTE Tx power of device to obtain 100s-averaged normalized SAR in LTE B4 PCC as shown in black curve. Similarly, equation (6b) is used to obtain 100s-averaged normalized SAR in LTE B5 SCC as shown in orange curve. Equation (6c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.566
Validated	

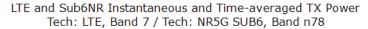
Plot Notes:

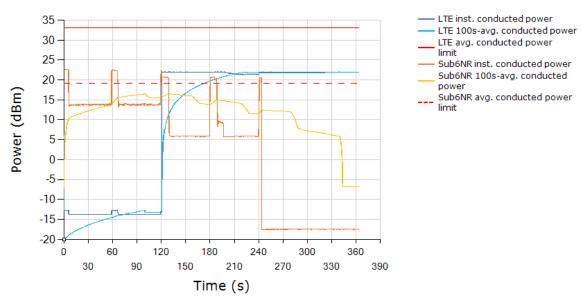
Device starts predominantly in SCC SAR exposure scenario between 0s and 120s, and in PCC SAR + SCC SAR exposure scenario between 120s and 240s, and in predominantly in PCC SAR exposure scenario after t=240s. Between 0s and 120s, PCC is at low power, however, SCC Tx power leakage (~30dB lower) due to filter/directional coupler characteristics in the measurement setup is shown as PCC power in the plot. Similarly, PCC leakage is shown as SCC power after t=240s. For predominantly PCC SAR exposure scenario, maximum normalized 1gSAR exposure should correspond to 100% exposure margin = 0.863W/kg measured SAR at LTE Plimit / 1.6W/kg limit = 0.54 +1dB device related uncertainty (see black curve after t = 240s).

Additionally, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target +1dB device uncertainty. In this test, with a maximum normalized SAR of 0.566 being \leq 0.79 (= 1/1.6 + 1dB device uncertainty), the above test result validated the continuity of power limiting in SAR exposure switch scenario.

5.9 Switch in SAR exposure test results (EN-DC Combination)

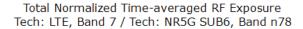
This test was conducted with callbox requesting maximum power, and with the EUT in LTE B7 + 5G NR n78 call. Following procedure detailed in Section 3.3.7 and Appendix B.2, and using the measurement setup shown in Figure 6-1, the SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios.

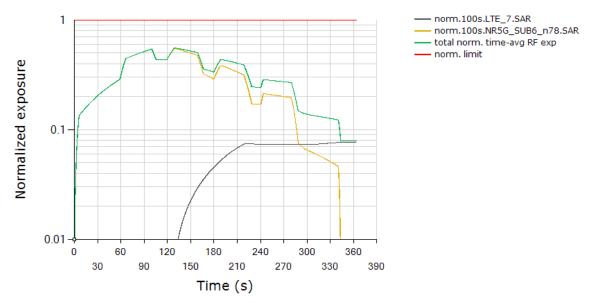




Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the LTE Tx power of device to obtain 100s-averaged normalized SAR in LTE B7 as shown in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in 5G NR n78 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).







	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.557
Validated	

Plot Notes:

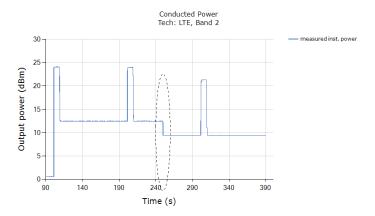
Device starts predominantly in 5G NR SAR exposure scenario between 0s and 120s, and in LTE SAR + 5G NR SAR exposure scenario between 120s and 240s, and in predominantly in LTE SAR exposure scenario after t=240s. Here, Smart Transmit allocates a maximum of 75% of exposure margin (based on 3dB reserve margin setting) for 5G NR. This corresponds to a normalized 1gSAR exposure value = 1.01W/kg measured SAR at 5G NR Plimit / 1.6W/kg limit = 0.631+ "+1dB \sim -1dB" device related uncertainty (see orange curve between 0s \sim 120s). For predominantly LTE SAR exposure scenario, maximum normalized 1gSAR exposure should correspond to 100% exposure margin = 0.139W/kg measured SAR at LTE Plimit /1.6W/kg limit = 0.087+ "+1dB \sim -1dB" device related uncertainty (see black curve after t = 240s). Additionally, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target +1dB device uncertainty. In this test, with a maximum normalized SAR of 0.557 being \leq 0.79 (=1/1.6 +1dB device uncertainty), the above test result validated the continuity of power limiting in SAR exposure switch scenario.

5.10 Verification of WWAN Backoff When WiFi/BT is Transmitting

This test was measured with LTE B2, DSI=3, and with callbox requesting maximum power. The call drop was manually performed when the EUT is transmitting at Preserve level as shown in the plot below (dotted black region). The measurement setup is shown in Figure 6-1. The detailed test procedure is described in Section 3.3.8.

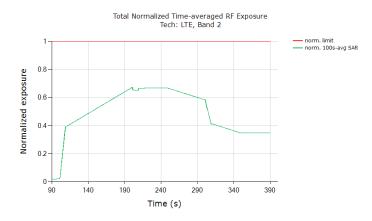
WWAN Backoff When WiFi/BT is Transmitting test result:

Plot 1: Measured conducted Tx power corresponding to Plimit for LTE B2 and reserve_power_margin set to 0 dB, callbox set to request maximum power and with WiFi turned OFF.



Plot Notes: ... The conducted power plot shows expected Tx transition.

Plot 2: Above time-averaged conducted Tx power is converted/calculated into time-averaged 1qSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1qSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.673
Validated	

The test result validated the continuity of power limiting in WiFi/BT is Transmitting scenario.

Page 55

6 SAR Test Results for Sub-6 Smart Transmit Feature Validation

6.1 Measurement setup

The measurement setup in Figure 7-1 is similar to normal SAR measurements (see Appendix F). The difference in SAR measurement setup for time averaging feature validation is that the callbox is signaling in close loop power control mode (instead of requesting maximum power in open loop control mode) and callbox is connected to the PC using GPIB so that the test script executed on PC can send GPIB commands to control the callbox's requested power over time (test sequence). The same test script used in conducted setup for time-varying Tx power measurements is also used in this section for running the test sequences during SAR measurements, and the recorded values from the disconnected power meter by the test script were discarded.

As mentioned in Section 3.4, for EUT to follow TPC command sent from the callbox wirelessly, the "path loss" between callbox antenna and the EUT needs to be very well calibrated. Since the SAR chamber is in uncontrolled environment, precautions must be taken to minimize the environmental influences on "path loss". Similarly, in the case of time-varying SAR measurements in 5G NR (with LTE as anchor), "path loss" between callbox antenna and the EUT needs to be carefully calibrated for both LTE link as well as for 5G NR link.

The EUT is placed in worst-case position according to Table 4-2.

6.2 SAR measurement results for time-varying Tx power transmission scenario

Following Section 3.4 procedure, time-averaged SAR measurements are conducted using EX3DV4 probe at peak location of area scan over 500 seconds. cDASY6 system verification for SAR measurement is provided in Appendix D, and the associated SPEAG certificates are attached in Appendix E.

SAR probe integration times depend on the communication signal being tested. Integration times used by SPEAG for their probe calibrations can be downloaded from here (integration time is listed on the bottom of the first page for each tech):

https://www.speag.com/assets/downloads/services/cs/UIDSummary171205.pdf

Since the sampling rate used by cDASY6 for pointSAR measurements is not in user control, the number of points in 100s or 60s interval is determined from the scan duration setting in cDASY6 time-average pointSAR measurement by (100s or 60s / cDASY6_scan_duration * total number of pointSAR values recorded). Running average is performed over these number of points in excel spreadsheet to obtain 100s-/60s-averaged pointSAR.

Following Section 3.4, for each of selected technology/band (listed in Table 4-2):

- 8. With *Reserve_power_margin* set to 0 dB, area scan is performed at *P*_{limit}, and time-averaged pointSAR measurements are conducted to determine the pointSAR at *P*_{limit} at peak location, denoted as *point*SAR_{Plimit}.
- With Reserve_power_margin set to actual (intended) value, two more time-averaged pointSAR measurements are performed at the same peak location for test sequences 1 and 2.

To demonstrate compliance, all the pointSAR measurement results were converted into 1gSAR or 10gSAR values by using Equation (3a), rewritten below:

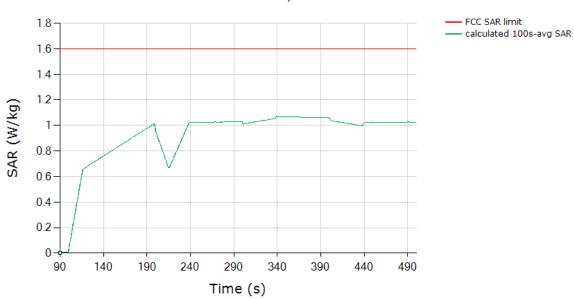
$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_P_{limit}} * 1g_or_10gSAR_P_{limit}$$
 (3a)

where, pointSAR(t), $pointSAR_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous point SAR, measured point SAR at P_{limit} from above step 1 and 2, and measured 1gSAR or 10gSAR values at P_{limit} obtained from Part 1 report and listed in Table 4-2 in Section 4.1 of this report.

6.2.1 GSM1900 SAR test results

SAR test results for test sequence 1:

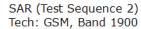
SAR (Test Sequence 1) Tech: GSM, Band 1900

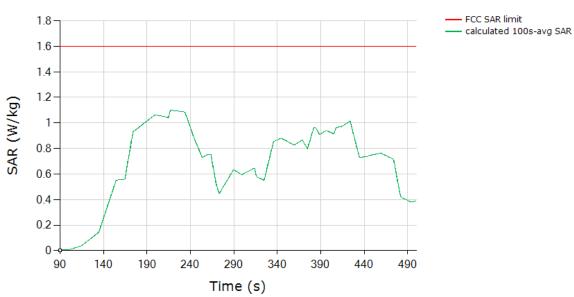


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.069
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	

Report No. : FA172701C

SAR test results for test sequence 2:





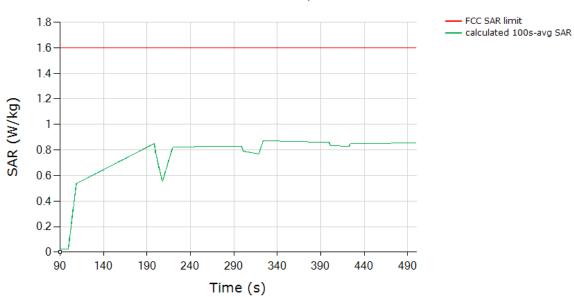
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.100
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB

device uncertainty

6.2.2 WCDMA B2 SAR test results

SAR test results for test sequence 1:

SAR (Test Sequence 1) Tech: WCDMA, Band 2

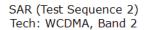


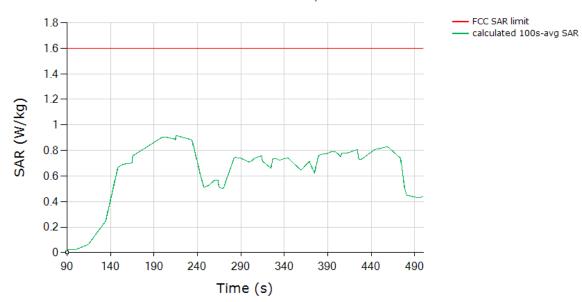
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.871
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB

Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB device uncertainty

Report No. : FA172701C

SAR test results for test sequence 2:





	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.918
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	

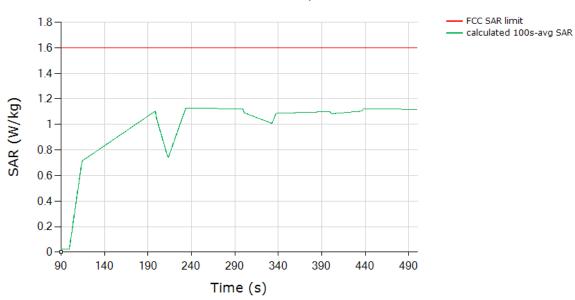
Page 61

Issued Date : Oct. 18, 2021

6.2.3 WCDMA B4 SAR test results

SAR test results for test sequence 1:

SAR (Test Sequence 1) Tech: WCDMA, Band 4



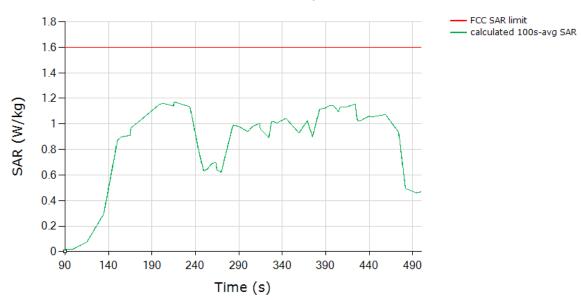
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.128
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	

Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dE device uncertainty

Report No. : FA172701C

SAR test results for test sequence 2:

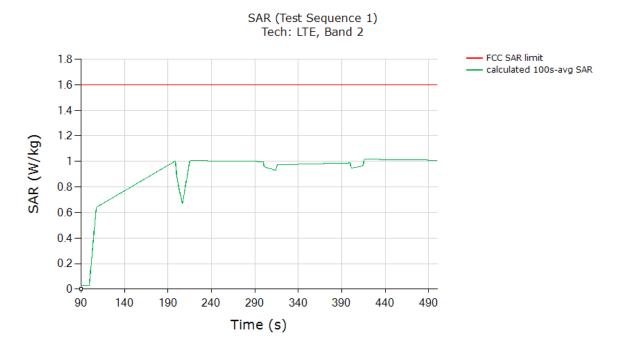




	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.172
Validated: Max time averaged SAR (green curve) does not exceed measured device uncertainty	I SAR at Plimit +1dB

6.2.4 LTE B2 SAR test results

SAR test results for test sequence 1:

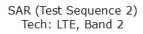


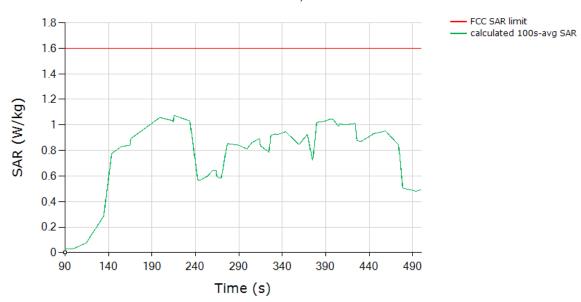
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.016
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB

Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dE device uncertainty

Report No. : FA172701C

SAR test results for test sequence 2:

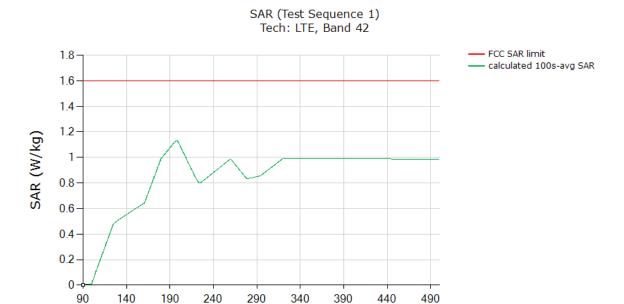




	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.075
Validated: Max time averaged SAR (green curve) does not exceed measured device uncertainty	SAR at Plimit +1dB

6.2.5 LTE B42 SAR test results

SAR test results for test sequence 1:



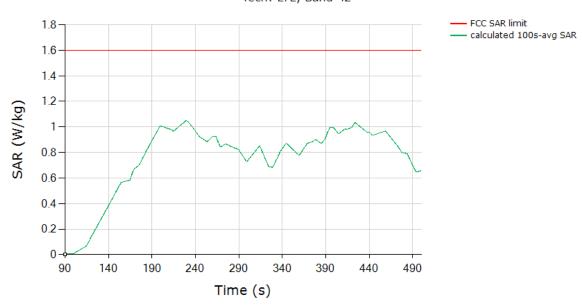
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.134
Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB	
device uncertainty	

Time (s)

Issued Date : Oct. 18, 2021

SAR test results for test sequence 2:

SAR (Test Sequence 2) Tech: LTE, Band 42

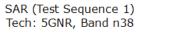


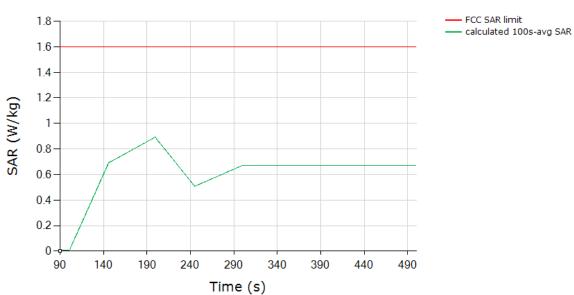
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.050
Validated: Max time averaged SAR (green curve) does not exc	ceed measured SAR at Plimit +1dB
device uncertainty	

Report No. : FA172701C

6.2.6 5G NR Band 38 SAR test results

SAR test results for test sequence 1:





	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.892
Validated: Max time averaged SAR (green curve) does not exceed measured device uncertainty	SAR at Plimit +1dB

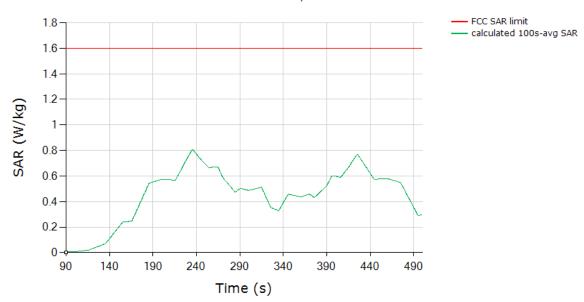
Page 68

Issued Date : Oct. 18, 2021

ure Report No. : FA172701C

SAR test results for test sequence 2:

SAR (Test Sequence 2) Tech: 5GNR, Band n38

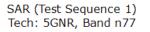


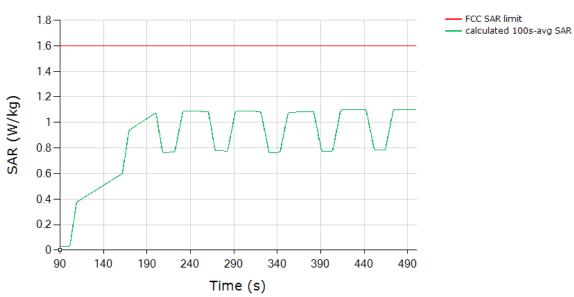
	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.807
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB
device uncertainty	

Report No. : FA172701C

6.2.7 5G NR Band 77 NSA SAR test results

SAR test results for test sequence 1:



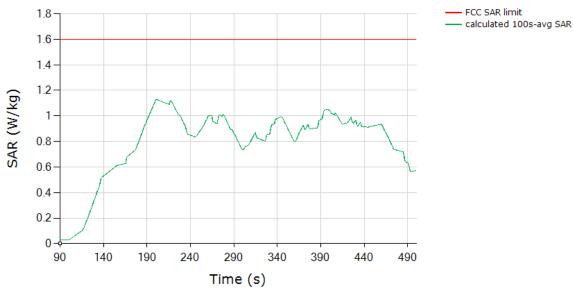


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.102
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB

Validated: Max time averaged SAR (green curve) does not exceed measured SAR at Plimit +1dB device uncertainty

SAR test results for test sequence 2:





SAR (Test Sequence 2)

	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	1.130
Validated: Max time averaged SAR (green curve) does not exceed measured	SAR at Plimit +1dB
device uncertainty	

7 Conclusions

Qualcomm Smart Transmit feature employed has been validated through the conducted/radiated power measurement, as well as SAR and PD measurement As demonstrated in this report, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0 for all the transmission scenarios described in Section 2. Therefore, the EUT complies with FCC RF exposure requirement



Appendix A. Test Sequences

- 1. Test sequence is generated based on below parameters of the EUT:
 - a. Measured maximum power (P_{max})
 - b. Measured Tx_power_at_SAR_design_target (Plimit)
 - c. Reserve_power_margin (dB)
 - P_{reserve} (dBm) = measured P_{limit} (dBm) Reserve_power_margin (dB)
 - d. SAR_time_window (100s for FCC)
- 2. Test Sequence 1 Waveform:

Based on the parameters above, the Test Sequence 1 is generated with one transition between high and low Tx powers. Here, high power = P_{max} ; low power = P_{max} /2, and the transition occurs after 80 seconds at high power P_{max} . As long as the power enforcement is taking into effective during one 100s/60s time window, the validation test with this defined test sequence 1 is valid, otherwise, select other radio configuration (band/DSI within the same technology group) having lower P_{limit} for this test. The Test sequence 1 waveform is shown below:

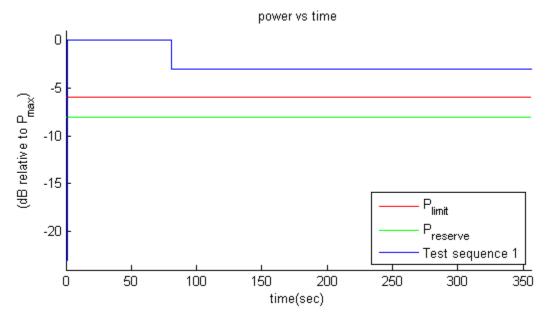


Figure 0-1 Test sequence 1 waveform

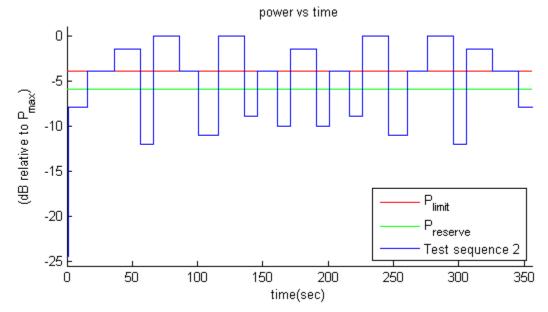
3. Test Sequence 2 Waveform:

Based on the parameters in A-1, the Test Sequence 2 is generated as described in Table 10-1, which contains two 170 second-long sequences (yellow and green highlighted rows) that are mirrored around the center row of 20s, resulting in a total duration of 360 seconds:

Table 0-1 Test Sequence 2

Time duration (seconds)	dB relative to Plimit or Preserve
<mark>15</mark>	P _{reserve} – 2
<mark>20</mark>	P _{limit}
<mark>20</mark>	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	Preserve – 6
<mark>20</mark>	P _{max}
<mark>15</mark>	P _{limit}
<mark>15</mark>	Preserve - 5
<mark>20</mark>	P _{max}
<mark>10</mark>	Preserve – 3
<mark>15</mark>	P _{limit}
<mark>10</mark>	P _{reserve} – 4
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
<mark>10</mark>	P _{reserve} – 4
<mark>15</mark>	Plimit
<mark>10</mark>	P _{reserve} – 3
<mark>20</mark>	P _{max}
<mark>15</mark>	Preserve – 5
<mark>15</mark>	Plimit
<mark>20</mark>	P _{max}
<mark>10</mark>	P _{reserve} – 6
<mark>20</mark>	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
<mark>20</mark>	Pimit
<mark>15</mark>	Preserve – 2





Appendix B. Test Procedures for 5G NR + LTE Radio

Appendix B provides the test procedures for validating Qualcomm Smart Transmit feature for LTE + 5G NR non-standalone (NSA) mode transmission scenario, where sub-6GHz LTE link acts as an anchor.

1 Time-varying Tx power test for 5G NR in NSA mode

Follows Section 3.2.1 to select test configurations for time-varying test. This test is performed with two pre-defined test sequences (described in Section 3.1) applied to 5G NR (with LTE on all-down bits or low power for the entire test after establishing the LTE+5G NR call with the callbox). Follow the test procedures described in Section 3.3.1 to demonstrate the effectiveness of power limiting enforcement and that the time averaged Tx power of 5G NR when converted into 1gSAR values does not exceed the regulatory limit at all times (see Eq. (1a) and (1b)). 5G NR response to test sequence1 and test sequence2 will be similar to other technologies (say, LTE), and are shown in Sections 6.3.7 and 6.3.8.

2 Switch in SAR exposure between LTE vs. 5G NR during transmission

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR for LTE radio only, SAR from both LTE radio and 5G NR, and SAR from 5G NR only scenarios, and ensures total time-averaged RF exposure compliance with FCC limit.

Test procedure:

- 1. Measure conducted Tx power corresponding to P_{limit} for LTE and 5G NR in selected band. Test condition to measure conducted P_{limit} is:
 - □ Establish device in call with the callbox for LTE in desired band. Measure conducted Tx power corresponding to LTE *P*_{limit} with Smart Transmit <u>enabled</u> and *Reserve power margin* set to 0 dB, callbox set to request maximum power.
 - □ Repeat above step to measure conducted Tx power corresponding to 5G NR $\underline{P_{limit}}$. If testing LTE+5G NR in non-standalone mode, then establish LTE+5G NR call with callbox and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from 5G NR, measured conducted Tx power corresponds to radio2 $\underline{P_{limit}}$ (as radio1 LTE is at all-down bits)
- 2. Set Reserve_power_margin to actual (intended) value with EUT setup for LTE + 5G NR call. First, establish LTE connection in all-up bits with the callbox, and then 5G NR connection is added with callbox requesting UE to transmit at maximum power in 5G NR. As soon as the 5G NR connection is established, request all-down bits on LTE link (otherwise, 5G NR will not have sufficient RF exposure margin to sustain the call with LTE in all-up bits). Continue LTE (all-down bits)+5G NR transmission for more than one time-window duration to test predominantly 5G NR SAR exposure

scenario (as SAR exposure is negligible from all-down bits in LTE). After at least one time-window, request LTE to go all-up bits to test LTE SAR and 5G NR SAR exposure scenario. After at least one more time-window, drop (or request all-down bits) 5G NR transmission to test predominantly LTE SAR exposure scenario. Continue the test for at least one more time-window. Record the conducted Tx powers for both LTE and 5G NR for the entire duration of this test.

- 3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and 5G NR links. Similar to technology/band switch test in Section 3.3.3, convert the conducted Tx power for both these radios into 1gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band *Plimit* measured in Step 1, and then perform 100s running average to determine time-averaged 1gSAR versus time as illustrated in Figure 3-1.
- 4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
- 5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory 1gSAR_{limit} of 1.6W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR versus time shall not exceed the regulatory 1gSAR_{limit} of 1.6W/kg.

Appendix C. Test Procedures for inter-band UL CA

Appendix C provides the test procedures for validating Qualcomm Smart Transmit feature for Switch in SAR exposure between PCC vs. SCC during inter-band ULCA transmission mode transmission scenario.

1 Switch in SAR exposure between PCC vs. SCC during inter-band ULCA transmission

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR for PCC radio only, SAR from both PCC & SCC radios, and SAR from SCC radio only scenarios, and ensures total time-averaged RF exposure compliance with FCC limit.

Test procedure:

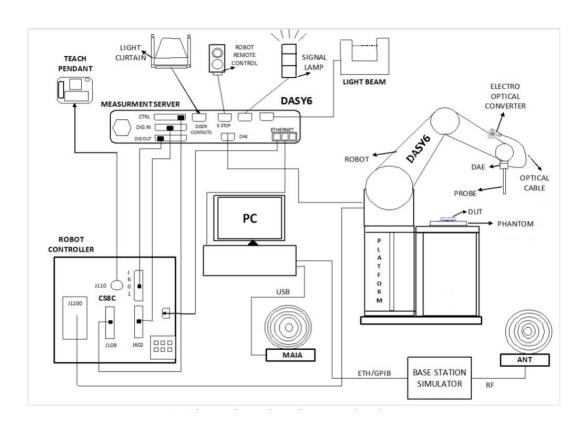
- 1. Measure *Plimit* for PCC and SCC in selected band. Test condition to measure conducted *Plimit* is:
 - □ Establish a LTE call with single active Tx in desired PCC band. Measure conducted Tx power corresponding to LTE *Plimit* with Smart Transmit enabled and *Reserve power margin* set to 0 dB, callbox set to request maximum power.
 - □ Repeat above step to measure *Plimit* corresponding to LTE SCC band under single active Tx scenario.
- 2. Set Reserve_power_margin to actual (intended) value, with EUT setup for interband ULCA call. First, establish interband ULCA connection with the callbox, and as soon as the connection is established, request all-down bits (or low power) on PCC link and then request UE to transmit at maximum power in SCC link. Continue PCC (all-down bits)+SCC transmission for more than one time-window duration to test predominantly SCC SAR exposure scenario (as SAR exposure from PCC is negligible from all-down bits). After at least one time-window, request PCC to go all-up bits to test PCC SAR and SCC SAR exposure scenario. After at least one more time-window, drop (or request all-down bits) SCC transmission to test predominantly PCC SAR exposure scenario. Continue the test for at least one more time-window. Record the conducted Tx powers for both PCC and SCC for the entire duration of this test.
- 3. Once the measurement is done, extract instantaneous Tx power versus time for both PCC and SCC links. Similar to technology/band switch test in Section 3.3.3, convert the conducted Tx power for both these radios into 1g_or_10gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band *Plimit* measured in Step 1, and then perform 100s running average to determine time-averaged 1g_or_10gSAR versus time as illustrated in Figure 5-1. Note that here it is assumed both radios have Tx frequencies < 3GHz, otherwise, 60s running average should be performed for radios having Tx frequency between 3GHz and 6GHz.</p>

- 4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
- 5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory 1g_or_10gSARlimit limit.
 The validation criteria is, at all times, the time-averaged 1g_or_10gSAR versus time shall not exceed the regulatory 1g_or_10gSARlimit limit.



Appendix D. cDASY6 System Verification

- 1 The system to be used for the near field power density measurement
- SPEAG DASY6 system
- SPEAG cDASY6 5G module software
- EUmmWVx probe
- 5G Phantom cover



2 Test Side Location

Sporton Lab and below test site location are accredited to ISO 17025 by Taiwan Accreditation Foundation (TAF code: 1190) and the FCC designation No. TW1190 under the FCC 2.948(e) by Mutual Recognition Agreement (MRA) in FCC test.

10011	
Test Site	SPORTON INTERNATIONAL INC. EMC & Wireless Communications Laboratory
Test Site Location	TW1190 No. 52, Huaya 1st Rd., Guishan Dist., Taoyuan City 333, CHINESE TAIPEI
Test Site No.	SAR06-HY



3 SAR E-Field Probe

Construction	Symmetric design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)			
Frequency	10 MHz – >6 GHz Linearity: ±0.2 dB (30 MHz – 6 GHz)			
Directivity	±0.3 dB in TSL (rotation around probe axis) ±0.5 dB in TSL (rotation normal to probe axis)			
Dynamic Range	10 μW/g – >100 mW/g Linearity: ±0.2 dB (noise: typically <1 μW/g)			
Dimensions	Overall length: 337 mm (tip: 20 mm) Tip diameter: 2.5 mm (body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm			



Report No.: FA172701C

4 Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200 MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80 dB.



Report No. : FA172701C

5 Test Equipment List

Manufacturer Name of Equipment Type/Model Serial Number Last Cal. Due Date SPEAG 835MHz System Validation Kit D835V2 4d167 Nov. 25, 2019 Nov. 23, 2021 SPEAG 1750MHz System Validation Kit D1750V2 11112 Mar. 07, 2019 Mar. 04, 2022 SPEAG 1900MHz System Validation Kit D1900V2 5d041 Aug. 19, 2021 Aug. 16, 2022 SPEAG 2600MHz System Validation Kit D3500V2 1008 Aug. 17, 2021 Aug. 16, 2022 SPEAG 3500MHz System Validation Kit D3500V2 1014 Jan. 29, 2019 Jan. 26, 2022 SPEAG 3500MHz System Validation Kit D3500V2 1017 Apr. 29, 2019 Jan. 26, 2022 SPEAG Data Acquisition Electronics DAE4 1424 Jan. 19, 2021 Jan. 18, 2022 SPEAG Dasimetric E-Field Probe EX3DV4 33931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe	Manufacturer		T /8/1	Carial Number	Calib	Calibration		
SPEAG 1750MHz System Validation Kit D1750V2 1112 Mar. 07, 2019 Mar. 04, 2022 SPEAG 1900MHz System Validation Kit D1900V2 5d041 Aug. 19, 2021 Aug. 18, 2022 SPEAG 2600MHz System Validation Kit D2600V2 1008 Aug. 17, 2021 Aug. 16, 2022 SPEAG 3500MHz System Validation Kit D3500V2 1014 Jan. 29, 2019 Jan. 26, 2022 SPEAG 3900MHz System Validation Kit D3900V2 1017 Apr. 29, 2019 Jan. 26, 2022 SPEAG 3900MHz System Validation Kit D3900V2 1017 Apr. 29, 2019 Jan. 26, 2022 SPEAG Data Acquisition Electronics DAE4 1424 Jan. 19, 2021 Jan. 18, 2022 SPEAG Dasimetric E-Field Probe EX3DV4 3931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 26, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500	Manufacturer	Name of Equipment	I ype/Model	Serial Number	Last Cal.	Due Date		
SPEAG 1900MHz System Validation Kit D1900V2 5d041 Aug. 19, 2021 Aug. 18, 2022 SPEAG 2600MHz System Validation Kit D2600V2 1008 Aug. 17, 2021 Aug. 16, 2022 SPEAG 3500MHz System Validation Kit D3500V2 1014 Jan. 29, 2019 Jan. 26, 2022 SPEAG 3900MHz System Validation Kit D3900V2 1017 Apr. 29, 2019 Apr. 26, 2022 SPEAG Data Acquisition Electronics DAE4 1424 Jan. 19, 2021 Jan. 18, 2022 SPEAG Data Acquisition Electronics DAE4 1647 Jan. 07, 2021 Jan. 06, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Apr. 25, 2022 R&S Base Station CMW500 115793 Nov. 23, 2020 Nov. 22, 2021 Testo Hygro meter 608-H1 45196600 </td <td>SPEAG</td> <td>835MHz System Validation Kit</td> <td>D835V2</td> <td>4d167</td> <td>Nov. 25, 2019</td> <td>Nov. 23, 2021</td>	SPEAG	835MHz System Validation Kit	D835V2	4d167	Nov. 25, 2019	Nov. 23, 2021		
SPEAG 2600MHz System Validation Kit D2600V2 1008 Aug. 17, 2021 Aug. 16, 2022 SPEAG 3500MHz System Validation Kit D3500V2 1014 Jan. 29, 2019 Jan. 26, 2022 SPEAG 3900MHz System Validation Kit D3900V2 1017 Apr. 29, 2019 Apr. 26, 2022 SPEAG Data Acquisition Electronics DAE4 1424 Jan. 19, 2021 Jan. 06, 2022 SPEAG Data Acquisition Electronics DAE4 1647 Jan. 07, 2021 Jan. 06, 2022 SPEAG Data Acquisition Electronics DAE4 1647 Jan. 07, 2021 Jan. 06, 2022 SPEAG Data Acquisition Electronics DAE4 1647 Jan. 07, 2021 Jan. 06, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500 115793 Nov. 20, 2021 Nov. 10, 2020 Nov. 20, 2021 Testo Hygro meter 608-H1	SPEAG	1750MHz System Validation Kit	D1750V2	1112	Mar. 07, 2019	Mar. 04, 2022		
SPEAG 3500MHz System Validation Kit D3500V2 1014 Jan. 29, 2019 Jan. 26, 2022 SPEAG 3900MHz System Validation Kit D3900V2 1017 Apr. 29, 2019 Apr. 26, 2022 SPEAG Data Acquisition Electronics DAE4 1424 Jan. 19, 2021 Jan. 18, 2022 SPEAG Data Acquisition Electronics DAE4 1647 Jan. 07, 2021 Jan. 06, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Apr. 25, 2022 R&S Base Station CMW500 115793 Nov. 20, 2021 Apr. 26, 2021	SPEAG	1900MHz System Validation Kit	D1900V2	5d041	Aug. 19, 2021	Aug. 18, 2022		
SPEAG 3900MHz System Validation Kit D3900V2 1017 Apr. 29, 2019 Apr. 26, 2022 SPEAG Data Acquisition Electronics DAE4 1424 Jan. 19, 2021 Jan. 18, 2022 SPEAG Data Acquisition Electronics DAE4 1647 Jan. 07, 2021 Jan. 06, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500 115793 Nov. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500 115793 Nov. 10, 2020 Nov. 22, 2021 Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021	SPEAG	2600MHz System Validation Kit	D2600V2	1008	Aug. 17, 2021	Aug. 16, 2022		
SPEAG Data Acquisition Electronics DAE4 1424 Jan. 19, 2021 Jan. 18, 2022 SPEAG Data Acquisition Electronics DAE4 1647 Jan. 07, 2021 Jan. 06, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500 115793 Nov. 23, 2020 Nov. 22, 2021 Testo Hygro meter 608-H1 45196600 Nov. 10, 2020 Nov. 09, 2021 Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 Nov. 10, 2021 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021	SPEAG	3500MHz System Validation Kit	D3500V2	1014	Jan. 29, 2019	Jan. 26, 2022		
SPEAG Data Acquisition Electronics DAE4 1647 Jan. 07, 2021 Jan. 06, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500 115793 Nov. 23, 2020 Nov. 22, 2021 Testo Hygro meter 608-H1 45196600 Nov. 10, 2020 Nov. 09, 2021 Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 A	SPEAG	3900MHz System Validation Kit	D3900V2	1017	Apr. 29, 2019	Apr. 26, 2022		
SPEAG Dosimetric E-Field Probe EX3DV4 3931 Oct. 22, 2020 Oct. 21, 2021 SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500 115793 Nov. 23, 2020 Nov. 22, 2021 Testo Hygro meter 608-H1 45196600 Nov. 10, 2020 Nov. 09, 2021 Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 <td>SPEAG</td> <td>Data Acquisition Electronics</td> <td>DAE4</td> <td>1424</td> <td>Jan. 19, 2021</td> <td>Jan. 18, 2022</td>	SPEAG	Data Acquisition Electronics	DAE4	1424	Jan. 19, 2021	Jan. 18, 2022		
SPEAG Dosimetric E-Field Probe EX3DV4 3642 Apr. 26, 2021 Apr. 25, 2022 SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500 115793 Nov. 23, 2020 Nov. 22, 2021 Testo Hygro meter 608-H1 45196600 Nov. 10, 2020 Nov. 09, 2021 Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 Nov. 10, 2021 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Sensor MR2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10,	SPEAG	Data Acquisition Electronics	DAE4	1647	Jan. 07, 2021	Jan. 06, 2022		
SPEAG Dosimetric E-Field Probe EX3DV4 3728 Feb. 23, 2021 Feb. 22, 2022 R&S Base Station CMW500 115793 Nov. 23, 2020 Nov. 22, 2021 Testo Hygro meter 608-H1 45196600 Nov. 10, 2020 Nov. 09, 2021 Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 Nov. 10, 2021 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Sensor MR2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022	SPEAG	Dosimetric E-Field Probe	EX3DV4	3931	Oct. 22, 2020	Oct. 21, 2021		
R&S Base Station CMW500 115793 Nov. 23, 2020 Nov. 22, 2021 Testo Hygro meter 608-H1 45196600 Nov. 10, 2020 Nov. 09, 2021 Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 Nov. 10, 2021 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Sensor MR2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2	SPEAG	Dosimetric E-Field Probe	EX3DV4	3642	Apr. 26, 2021	Apr. 25, 2022		
Testo Hygro meter 608-H1 45196600 Nov. 10, 2020 Nov. 09, 2021 Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 Nov. 10, 2021 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Sensor MA2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021	SPEAG	Dosimetric E-Field Probe	EX3DV4	3728	Feb. 23, 2021	Feb. 22, 2022		
Testo Hygro meter 608-H1 45207528 Nov. 10, 2020 Nov. 09, 2021 Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 Nov. 10, 2021 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Sensor MA2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023	R&S	Base Station	CMW500	115793	Nov. 23, 2020	Nov. 22, 2021		
Anritsu Spectrum Analyzer N9010A MY53470118 Jan. 15, 2021 Jan. 14, 2022 Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 Nov. 10, 2021 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Sensor MA2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 N	Testo	Hygro meter	608-H1	45196600	Nov. 10, 2020	Nov. 09, 2021		
Anritsu Signal Generator MG3710A 6201502524 Nov. 11, 2020 Nov. 10, 2021 Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Sensor MA2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1	Testo	Hygro meter	608-H1	45207528	Nov. 10, 2020	Nov. 09, 2021		
Anritsu Power Meter ML2495A 1419002 Aug. 18, 2021 Aug. 17, 2022 Anritsu Power Sensor MA2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuat	Anritsu	Spectrum Analyzer	N9010A	MY53470118	Jan. 15, 2021	Jan. 14, 2022		
Anritsu Power Sensor MA2411B 1911176 Aug. 18, 2021 Aug. 17, 2022 R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 321501827 Sep. 06, 2021 Sep. 05, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1	Anritsu	Signal Generator	MG3710A	6201502524	Nov. 11, 2020	Nov. 10, 2021		
R&S Power Sensor NRP8S 109688 Sep. 15, 2021 Sep. 14, 2022 R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 321501827 Sep. 06, 2021 Sep. 05, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	Anritsu	Power Meter	ML2495A	1419002	Aug. 18, 2021	Aug. 17, 2022		
R&S Power Sensor NRP8S 103999 Jan. 06, 2021 Jan. 05, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 321501827 Sep. 06, 2021 Sep. 05, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	Anritsu	Power Sensor	MA2411B	1911176	Aug. 18, 2021	Aug. 17, 2022		
Mini-Circuits Power Amplifier ZHL-42W+ 715701915 May. 11, 2021 May. 10, 2022 Mini-Circuits Power Amplifier ZHL-42W+ 321501827 Sep. 06, 2021 Sep. 05, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	R&S	Power Sensor	NRP8S	109688	Sep. 15, 2021	Sep. 14, 2022		
Mini-Circuits Power Amplifier ZHL-42W+ 321501827 Sep. 06, 2021 Sep. 05, 2022 SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	R&S	Power Sensor	NRP8S	103999	Jan. 06, 2021	Jan. 05, 2022		
SCHWARZBECK SHF-EHF Horn Antenna BBHA 9170 BBHA9170251 Nov. 26, 2020 Nov. 25, 2021 Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	Mini-Circuits	Power Amplifier	ZHL-42W+	715701915	May. 11, 2021	May. 10, 2022		
Keysight Wireless Communication Test Set E5515C MY50267236 Mar. 21, 2021 Mar. 20, 2022 Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	Mini-Circuits	Power Amplifier	ZHL-42W+	321501827	Sep. 06, 2021	Sep. 05, 2022		
Bojay mmwave measurement horn antenna AQRH-15 000023 Note 1 Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	SCHWARZBECK	SHF-EHF Horn Antenna	BBHA 9170	BBHA9170251	Nov. 26, 2020	Nov. 25, 2021		
Warison 10-50 GHz Directional Coupler WCOU-10-50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	Keysight	Wireless Communication Test Set	E5515C	MY50267236	Mar. 21, 2021	Mar. 20, 2022		
Warison 10-50 GHz Directional Coupler 50S-10 WR889BMC481 Note 1 ATM 500M-18GHz Dual Directional Coupler C122H-10 P610410z-02 Note 1 Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	Bojay	mmwave measurement horn antenna	AQRH-15	000023	Note 1			
Woken Attenuator 1 WK0602-XX N/A Note 1 PE Attenuator 2 PE7005-10 N/A Note 1	Warison	10-50 GHz Directional Coupler		WR889BMC481	Note 1			
PE Attenuator 2 PE7005-10 N/A Note 1	ATM	500M-18GHz Dual Directional Coupler	C122H-10	P610410z-02	Note 1			
	Woken	Attenuator 1	WK0602-XX	N/A	Note 1			
PE Attenuator 3 PE7005- 3 N/A Note 1	PE	Attenuator 2	PE7005-10	N/A	No	te 1		
	PE	Attenuator 3	PE7005- 3	N/A	No	te 1		

General Note:

Prior to system verification and validation, the path loss from the signal generator to the system check source and the power meter, which includes the amplifier, cable, attenuator and directional coupler, was measured by the network analyzer. The reading of the power meter was offset by the path loss difference between the path to the power meter and the path to the system check source to monitor the actual power level fed to the system check source.
 The dipole calibration interval can be extended to 3 years with justification according to KDB 865664 D01. The dipoles are also

^{2.} The dipole calibration interval can be extended to 3 years with justification according to KDB 865664 D01. The dipoles are also not physically damaged, or repaired during the interval. The justification data in appendix C can be found which the return loss is < -20dB, within 20% of prior calibration, the impedance is within 5 ohm of prior calibration for each dipole.

SAR system verification and validation

8.1. Tissue Verification

The following tissue formulations are provided for reference only as some of the parameters have not been thoroughly verified. The composition of ingredients may be modified accordingly to achieve the desired target tissue parameters required for routine SAR evaluation.

Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity (σ)	Permittivity (εr)
835	40.3	57.9	0.2	1.4	0.2	0	0.90	41.5
1750, 1900, 2000	55.2	0	0	0.3	0	44.5	1.40	40.0
2300	55.0	0	0	0	0	45.0	1.67	39.5
2600	54.8	0	0	0.1	0	45.1	1.96	39.0

Simulating Liquid for 5GHz, Manufactured by SPEAG

Ingredients	(% by weight)
Water	64~78%
Mineral oil	11~18%
Emulsifiers	9~15%
Additives and Salt	2~3%

<Tissue Check Results>

Frequency (MHz)	Liquid Temp. (℃)	Conductivity (σ)	Permittivity (ε _r)	Conductivity Target (σ)	Permittivity Target (ε _r)	Delta (σ) (%)	Delta (ε _r) (%)	Limit (%)	Date
835	22.5	0.910	41.200	0.90	41.50	1.11	-0.72	±5	2021/10/13
1750	22.5	1.410	40.500	1.37	40.10	2.92	1.00	±5	2021/10/13
1900	22.5	1.460	41.300	1.40	40.00	4.29	3.25	±5	2021/10/13
2600	22.5	1.910	38.200	1.96	39.00	-2.55	-2.05	±5	2021/10/13
3500	22.5	2.970	37.800	2.91	37.90	2.06	-0.26	±5	2021/10/13
3900	22.5	3.210	36.500	3.33	37.51	-3.60	-2.69	±5	2021/10/13

8.1. System Verification

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10 %. Below table shows the target SAR and measured SAR after normalized to 1W input power. The table below indicates the system performance check can meet the variation criterion and the plots can be referred to Appendix D.

<System Verification Results>

Date	Frequency (MHz)	Input Power (mW)	Dipole S/N	Probe S/N	DAE S/N	Measured 1g SAR (W/kg)	Targeted 1g SAR (W/kg)	Normalized 1g SAR (W/kg)	Deviation (%)
2021/10/13	835	250	D835V2-4d167	EX3DV4 - SN3931	DAE4 Sn1424	2.47	9.55	9.88	3.46
2021/10/13	1750	250	D1750V2-1112	EX3DV4 - SN3931	DAE4 Sn1424	9.87	36.70	39.48	7.57
2021/10/13	1900	250	D1900V2-5d041	EX3DV4 - SN3642	DAE4 Sn1647	9.73	40.20	38.92	-3.18
2021/10/13	2600	250	D2600V2-1008	EX3DV4 - SN3642	DAE4 Sn1647	14.30	56.40	57.2	1.42
2021/10/13	3500	100	D3500V2-1014	EX3DV4 - SN3728	DAE4 Sn1424	7.33	67.90	73.3	7.95
2021/10/13	3900	100	D3900V2-1017	EX3DV4 - SN3931	DAE4 Sn1424	6.52	69.50	65.2	-6.19

Page 82